

TA Technology (Shanghai) Co., Ltd. Test Report

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ANSI C63.19 TEST REPORT

| Product Name | GSM Quad Band Mobile Phone | |
|----------------|----------------------------|--|
| Model Name | Xpress | |
| Marketing Name | one touch 838 | |
| FCC ID | RAD265 | |
| Client | TCT Mobile Limited | |

TA Technology (Shanghai) Co., Ltd.

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RXA1204-0112HAC01

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GENERAL SUMMARY

| Product Name | GSM Quad Band Mobile Phone | Model | Xpress |
|--------------------------|---|---------|--------------------|
| Report No. | RXA1204-0112HAC01 | FCC ID | RAD265 |
| Client | TCT Mobile Limited | | |
| Manufacturer | TCT Mobile Limited | | |
| Reference Standard(s) | ANSI C63.19-2007: American National Standard Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids. | | |
| | This portable wireless equipment has been measured in all cases requested by the relevant standards. | | |
| Conclusion | General Judgment: M3 (RF Emission) (Stamp) Date of issue: May 15 th , 2012 | | |
| Comment | The test result only responds to the measured sample. | | |
| pproved by | ま 中 Revised by HAC Mana | Perform | ed by HAC Engineer |
| • | | 0 | |

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1. General Information

1.1. Notes of the Test Report

TA Technology (Shanghai) Co., Ltd. guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at TA Technology (Shanghai) Co., Ltd. at the time of execution of the test.

TA Technology (Shanghai) Co., Ltd. is liable to the client for the maintenance by its personnel of the confidentiality of all information related to the items under test and the results of the test. This report only refers to the item that has undergone the test.

This report standalone dose not constitute or imply by its own an approval of the product by the certification Bodies or competent Authorities. This report cannot be used partially or in full for publicity and/or promotional purposes without previous written approval of **TA Technology (Shanghai) Co., Ltd.** and the Accreditation Bodies, if it applies.

If the electrical report is inconsistent with the printed one, it should be subject to the latter.

1.2. Testing Laboratory

| Company: | TA Technology (Shanghai) Co., Ltd. |
|------------|--|
| Address: | No.145, Jintang Rd, Tangzhen Industry Park, Pudong Shanghai, China |
| City: | Shanghai |
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| E-mail: | yangweizhong@ta-shanghai.com |

1.3. Applicant Information

| Company: | TCT Mobile Limited |
|--------------|---|
| Address: | 5F, E building, No. 232, Liang Jing Road ZhangJiang High-Tech Park, Pudong Area Shanghai, P.R. China. 201203 |
| City: | Shanghai |
| Postal Code: | 201203 |
| Country: | P.R. China |
| Contact: | Gong Zhizhou |
| Telephone: | 0086-21-61460890 |
| Fax: | 0086-21-61460602 |

1.4. Manufacturer Information

| Company: | TCT Mobile Limited |
|--------------|--|
| Address: | 5F, E building, No. 232, Liang Jing Road ZhangJiang High-Tech Park, Pudong Area Shanghai, P.R. China. 201203 |
| City: | Shanghai |
| Postal Code: | 201203 |
| Country: | P.R. China |
| Telephone: | 0086-21-61460890 |
| Fax: | 0086-21-61460602 |

1.5. Information of EUT

General Information

| Device Type: | Portable Device | | |
|--|---|-----------------|-----------------|
| Product Name: | GSM Quad Band Mobile Phone | | |
| IMEI: | 863744010510161 | | |
| Hardware Version: | PIO | | |
| Software Version: | E16 | | |
| Antenna Type: | Internal Antenna | | |
| Device Operating Configurations: | | | |
| Supporting Mode(c): | GSM 850/ GSM 1900; | (tested) | |
| Supporting Mode(s): | WIFI/Bluetooth; (untest | ted) | |
| Test Modulation: | (GSM)GMSK | | |
| Device Class: | В | | |
| | Max Number of Timeslots in Uplink | | 4 |
| GPRS Multislot Class(12): | Max Number of Timeslots in Downlink | | 4 |
| | Max Total Timeslot | | 5 |
| | Max Number of Timeslots in Uplink | | 4 |
| EGPRS Multislot Class(12): | Max Number of Timeslots in Downlink | | 4 |
| | Max Total Timeslot | | 5 |
| | Mode | Tx (MHz) | Rx (MHz) |
| Operating Frequency Range(s): | GSM 850 | 824.2 ~ 848.8 | 869.2 ~ 893.8 |
| | GSM 1900 | 1850.2 ~ 1909.8 | 1930.2 ~ 1989.8 |
| Test Channel: (Low - Middle - High) | 128-190-251(GSM 850) (tested)512-661-810(GSM 1900) (tested) | | |
| Dower Close | GSM 850: 4, tested with power level 5 | | |
| Power Class: | GSM 1900: 1, tested with power level 0 | | |

Auxiliary Equipment Details

| Name | Model | Manufacturer | S/N |
|-----------|--------------|--------------|------------------|
| Battery 1 | CAB31L0000C1 | BYD | B347060109A |
| Battery 2 | CAB31L0000C2 | BAK | BAK2011051800969 |

Equipment Under Test (EUT) is a GSM Quad Band Mobile Phone. The device has an internal antenna for GSM Tx/Rx, and the other is BT antenna that is used for Tx/Rx. The EUT has Personal Wireless Routers (hot spots) function .The detail about EUT and Lithium Battery is in chapter 1.5 in this report. HAC is tested for GSM 850 and GSM 1900. WIFI/Bluetooth mode doesn't have voice capability, and it doesn't operate in the held to ear mode for providing handset service.

The sample under test was selected by the Client.

Components list please refer to documents of the manufacturer.

1.6. The Ambient Conditions during Test

| Temperature | Min. = 18°C, Max. = 28 °C | |
|---|---------------------------|--|
| Relative humidity | Min. = 0%, Max. = 80% | |
| Ground system resistance | < 0.5 Ω | |
| Ambient noise is checked and found very low and in compliance with requirement of standards. | | |
| Reflection of surrounding objects is minimized and in compliance with requirement of standards. | | |

1.7. The Total M-rating of each tested band

| Mode | Rating |
|----------|--------|
| GSM 850 | М3 |
| GSM 1900 | М3 |

1.8. Test Date

The test performed from May 7, 2012 to May 8, 2012.

2. Test Information

2.1. Operational Conditions during Test

2.1.1. General Description of Test Procedures

The phone was tested in all normal configurations for the ear use. The EUT is mounted in the device holder equivalent as for classic dosimeter measurements. The acoustic output of the EUT shall coincide with the center point of the area formed by the dielectric wire and the middle bar of the arch's top frame The EUT shall be moved vertically upwards until it touches the frame. The fine adjustment is possible by sliding the complete. The EUT holder is on the yellow base plate of the Test Arch phantom. These test configurations are tested at the high, middle and low frequency channels of each applicable operating mode; for example, GSM, WCDMA (UMTS), CDMA and TDMA.

Test Report

2.1.2. GSM Test Configuration

A communication link is set up with a System Simulator (SS) by air link, and a call is established. The Absolute Radiofrequency Channel Number (ARFCN) is allocated to 128, 190 and 251 in the case of GSM 850, to 512, 661 and 810 in the case of GSM 1900. The EUT is commanded to operate at maximum transmitting power. Using E5515C the power lever is set to "5" for GSM 850, set to "0" for GSM 1900. The test in the bands of GSM 850 and GSM 1900 are performed in the mode of speech transfer function.

2.2. HAC RF Measurements System Configuration

2.2.1. HAC Measurement Set-up

These measurements are performed using the DASY4 automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. Cell controller systems contain the power supply, robot controller, teach pendant (Joystick) and remote control, and are used to drive the robot motors. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification; signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

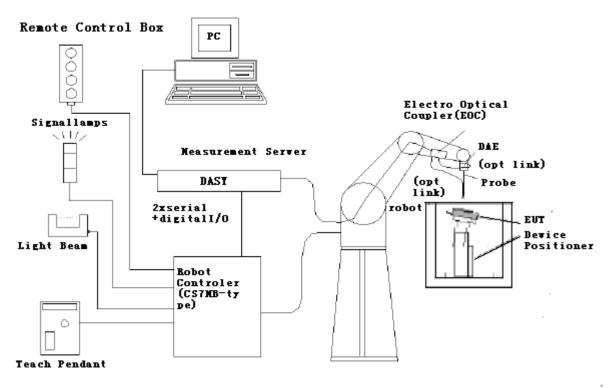


Figure 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

2.2.2. Probe System

The HAC measurements were conducted with the E-Field Probe ER3DV6 and the H-Field Probe H3DV6 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

E-Field Probe Description

| Construction | One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material | ITE |
|---------------|--|----------------------------------|
| Calibration | In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$, k=2) | |
| Frequency | 40 MHz to > 6 GHz (can be extended to < 20 MHz) Linearity: ± 0.2 dB (100 MHz to 3 GHz) | Figure 2 ER3DV6 E-field Probe |
| Directivity | ± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis) | |
| Dynamic Range | 2 V/m to > 1000 V/m; Linearity: ± 0.2 dB | |
| Dimensions | Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm | |
| Application | General near-field measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms | |

H-Field Probe Description

| Construction | Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges PEEK enclosure material (resistant to organic | |
|-------------------------|--|---------------------------------|
| Frequency | solvents, e.g., glycolether) 200 MHz to 3 GHz (absolute accuracy ± 6.0%, k=2); | Figure 3 H3DV6 H-field Probe |
| | Output linearized | FIDDe |
| Directivity | ± 0.2 dB (spherical isotropy error) | |
| Dynamic Range | 10 mA/m to 2 A/m at 1 GHz | |
| E-Field Interference | < 10% at 3 GHz (for plane wave) | |
| Dimensions | Overall length: 330 mm (Tip: 40 mm) | |
| | Tip diameter: 6 mm (Body: 12 mm) | |
| | Distance from probe tip to dipole centers: 3 mm | |

| Application | General magnetic near-field measurements up to 3 |
|-------------|--|
| | GHz (in air or liquids) |
| | Field component measurements |
| | Surface current measurements |
| | Low interaction with the measured field |

2.2.3. Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: 370 x 370 x 370 mm).

The Device reference point is set for the EUT at 6.3 mm, the Grid reference point is on the upper surface at the origin of the coordinates, and the "user point \Height Check 0.5 mm" is 0.5mm above the center, allowing verication of the gap of 0.5mm while the probe is positioned there.

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field $\leq \pm 0.5$ dB.

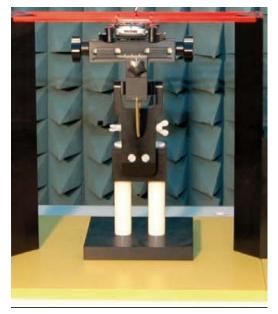


Figure 4 HAC Phantom & Device Holder

2.3. RF Test Procedures

The evaluation was performed with the following procedure:

- 1. Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
- Position the WD in its intended test position. The gauge block can simplify this positioning. Note that a separate E-field and H-field gauge block will be needed if the center of the probe sensor elements is at different distances from the tip of the probe.
- 3. Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
- 4. The center sub-grid shall center on the center of the axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
- 5. Record the reading.
- 6. Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
- 7. Identify the five contiguous sub-grids around the center sub-grid with the lowest maximum field strength readings. Thus the six areas to be used to determine the WD's highest emissions are identified and outlined for the final manual scan. Please note that a maximum of five blocks can be excluded for both E-field and H-field measurements for the WD output being measured. Stated another way, the center sub-grid and three others must be common to both the E-field and H-field measurements.
- 8. Identify the maximum field reading within the non-excluded sub-grids identified in Step 7.
- 9. Convert the maximum field strength reading identified in Step 8 to V/m or A/m, as appropriate. For probes which require a probe modulation factor, this conversion shall be done using the appropriate probe modulation factor and the calibration.
- 10. Repeat Step 1 through Step 10 for both the E-field and H-field measurements.
- 11. Compare this reading to the categories in ANSI C63.19 Clause 7 and record the resulting category. The lowest category number listed in 7.2, Table 7.4, or Table 7.5 obtained in Step 10 for either E- or H-field determines the M category for the audio coupling mode assessment. Record the WD category rating.

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Figure 5 WD reference and plane for RF emission measurements

2.4. System Check

Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 D.5 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field and H-field probes so that:

The probes and their cables are parallel to the coaxial feed of the dipole antenna.

The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions.

The center point of the probe element(s) are 10 mm from the closest surface of the dipole elements. Validation was performed to verify that measured E-field and H-field values are within +/-25% from the target reference values provided by the manufacturer. "Values within +/-25% are acceptable. Of which 12% is deviation and 13% is measurement uncertainty."

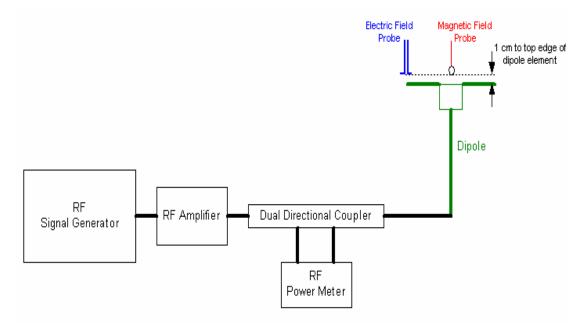


Figure 6 Dipole Validation Setup

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Dipole Measurement Summary

| | E-Field Scan | | | | | | |
|---|--------------------|---------------------|----------------------------------|-------|------------------|--|--|
| Mode | Frequency (MHz) | Input Power (mW) | Value | | Test Date | | |
| | | | Target ¹ Value(V/m) | 161.4 | February 21,2012 | | |
| CW | 835 | 100 | Measured ² Value(V/m) | 166.3 | May 7, 2012 | | |
| | | | Deviation ³ (%) | 3.04 | 1 | | |
| | | | Target ¹ Value(V/m) | 143.4 | February 21,2012 | | |
| CW | 1880 | 100 | Measured ² Value(V/m) | 140.9 | May 8, 2012 | | |
| | | | Deviation ³ (%) | -1.74 | 1 | | |
| | | | H-Field Scan | | | | |
| Mode | Frequency (MHz) | Input Power (mW) | Value | | Test Date | | |
| | | | Target ¹ Value(A/m) | 0.460 | February 21,2012 | | |
| | | | Measured ² Value(A/m) | 0.473 | May 7, 2012 | | |
| CW | 835 | 100 | Deviation ³ (%) | 2.83 | 1 | | |
| | | | Measured ² Value(A/m) | 0.466 | May 8, 2012 | | |
| | | | Deviation ³ (%) | 1.30 | 1 | | |
| | | | Target ¹ Value(A/m) | 0.470 | February 21,2012 | | |
| | | | Measured ² Value(A/m) | 0.463 | May 7, 2012 | | |
| CW | 1880 | 100 | Deviation ³ (%) | -1.49 | / | | |
| | | | Measured ² Value(A/m) | 0.459 | May 8, 2012 | | |
| | | | Deviation ³ (%) | -2.34 | 1 | | |
| Notes: 1. Target value is provided by SPEAD in the calibration certificate of specific dipoles. 2. Please refer to the attachment for detailed measurement data and plot. 3. Deviation (%) = 100 * (Measured value minus Target value) divided by Target value. | | | | | | | |

2.5. Probe Modulation Factor

The Probe Modulation Factor (PMF) is defined as the ratio of the field readings for a CW and a modulated signal with the equivalent Field Envelope Peak as defined in ANSI C63.19 (Chapter C.3.1).Calibration shall be made of the modulation response of the probe and its instrumentation chain. This Calibration shall be performed with the field probe, attached to the instrumentation that is to be used with it during the measurement. The response of the probe system to a CW field at the frequency(s) of interest is compared to its response to a modulated signal with equal peak amplitude. The field level of the test signals shall be more than 10dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated field shall be applied to the readings taken of modulated fields of the specified type.

Modulation Factor Test Procedure

This may be done using the following procedure:

- 1. Fix the field probe in a set location relative to a field generating device, such as the reference dipole antenna.
- 2. Illuminate the probe using the wireless device connected to the reference dipole with a test signal at the intended measurement frequency, Ensure there is sufficient field coupling between the probe and the antenna so the resulting reading is greater than 10 dB above the probe system noise floor but within the systems operating range.
- 3. Record the amplitude applied to the antenna during transmission and the field strength measured by the E-field probe located near the tip of the dipole antenna
- 4. Replace the wireless device with an RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
- 5. Set the amplitude of the unmodulated signal to equal that recorded from the wireless device.
- 6. Record the reading of the probe measurement system of the unmodulated signal.
- The ratio, in linear units, of the probe reading in Step 6 to the reading in Step 3 is the E-field modulation factor. PMF_E = E_{CW} / E_{mod} (PMF_H = H_{CW} / H_{mod})
- 8. Repeat the previous steps using the H-field probe, except locate the probe at the center of the dipole.

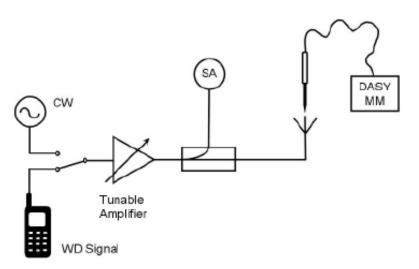


Figure 7 Probe Modulation Factor Test Setup

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| Band | E-Field Probe Modulation Factor | H-Field Probe Modulation Factor |
|----------|------------------------------------|------------------------------------|
| GSM 850 | 2.81 | 2.75 |
| GSM 1900 | 2.84 | 2.84 |

2.6. Conducted Output Power Measurement

Summary

The EUT is tested using an E5515C communications tester as controller unit to set test channels and maximum output power to the EUT, as well as for measuring the conducted power. Conducted output power was measured using an integrated RF connector and attached RF cable. This result contains conducted output power for the EUT.

Conducted Power Results

| GSM 850 | Conducted Power(dBm) | | | | |
|--------------|----------------------|-------------|-------------|--|--|
| 6314 650 | Channel 128 | Channel 190 | Channel 251 | | |
| Test Results | 32.56 | 32.57 | 32.51 | | |
| CSM 4000 | Conducted Power(dBm) | | | | |
| GSM 1900 | Channel 512 | Channel 661 | Channel 810 | | |
| Test Results | 29.67 | 29.48 | 29.45 | | |

3. Test Results

3.1. ANSI C63.19-2007 Limits

| Category | | Telephone RF parameters < 960 MHz | | | | | | |
|----------------|-----|-----------------------------------|-------|-------------------|-------|--|--|--|
| Near field | AWF | E-field emis | sions | H-field emiss | sions | | | |
| Category M1/T1 | 0 | 631.0 to 1122.0 | V/m | 1.91 to 3.39 | A/m | | | |
| | -5 | 473.2 to 841.4 | V/m | 1.43 to 2.54 | A/m | | | |
| Category M2/T2 | 0 | 354.8 to 631.0 | V/m | 1.07 to 1.91 | A/m | | | |
| | -5 | 266.1 to 473.2 | V/m | 0.80 to 1.43 | A/m | | | |
| Cotogony M2/T2 | 0 | 199.5 to 354.8 | V/m | 0.60 to 1.07 | A/m | | | |
| Category M3/T3 | -5 | 149.6 to 266.1 | V/m | 0.45 to 0.80 | A/m | | | |
| Cotogon M4/T4 | 0 | < 199.5 | V/m | < 0.60 | A/m | | | |
| Category M4/T4 | -5 | < 149.6 | V/m | < 0.45 | A/m | | | |
| Category | | Telephone RF parameters > 960 MHz | | | | | | |
| Near field | AWF | E-field emiss | sions | H-field emissions | | | | |
| Category M1/T1 | 0 | 199.5 to 354.8 | V/m | 0.60 to 1.07 | A/m | | | |
| | -5 | 149.6 to 266.1 | V/m | 0.45 to 0.80 | A/m | | | |
| Catagony M2/T2 | 0 | 112.2 to 199.5 | V/m | 0.34 to 0.60 | A/m | | | |
| Category M2/T2 | -5 | 84.1 to 149.6 | V/m | 0.25 to 0.45 | A/m | | | |
| Cotogon M2/T2 | 0 | 63.1 to 112.2 | V/m | 0.19 to 0.34 | A/m | | | |
| Category M3/T3 | -5 | 47.3 to 84.1 | V/m | 0.14 to 0.25 | A/m | | | |
| Cotogon/ M4/T4 | 0 | < 63.1 | V/m | < 0.19 | A/m | | | |
| Category M4/T4 | -5 | < 47.3 | V/m | < 0.14 | A/m | | | |

3.2. Summary Test Results

GSM 850 Results

| | E-Field with Battery 1 | | | | | | |
|------------|------------------------|------------------|------------------|--------|------------------|--|--|
| Channel | Frequency (MHz) | Peak Field (V/m) | Power Drift (dB) | Rating | Graph Results | | |
| High/251 | 848.8 | 181.1 | 0.073 | M3 | Figure 14 | | |
| Middle/190 | 836.6 | 185.5 | -0.024 | М3 | Figure 15 | | |
| Low/128 | 824.2 | 189.8 | 0.043 | М3 | Figure 16 | | |
| | | E-Field with B | attery 2 | | | | |
| Low/128 | 824.2 | 190.6 | 0.013 | М3 | Figure 17 | | |
| | | H-Field with B | attery 1 | | | | |
| Channel | Frequency (MHz) | Peak Field (A/m) | Power Drift (dB) | Rating | Graph Results | | |
| High/251 | 848.8 | 0.251 | 0.005 | M4 | Figure 18 | | |
| Middle/190 | 836.6 | 0.25 | 0.057 | M4 | Figure 19 | | |
| Low/128 | 824.2 | 0.247 | 0.001 | M4 | Figure 20 | | |
| | • | H-Field with B | attery 2 | | · | | |
| High/251 | 848.8 | 0.256 | -0.077 | M4 | Figure 21 | | |

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| | E-Field with Battery 1 | | | | | | |
|------------|------------------------|------------------|------------------|--------|------------------|--|--|
| Channel | Frequency (MHz) | Peak Field (V/m) | Power Drift (dB) | Rating | Graph Results | | |
| High/810 | 1909.8 | 69.6 | 0.015 | М3 | Figure 22 | | |
| Middle/661 | 1880 | 67.3 | -0.09 | M3 | Figure 23 | | |
| Low/512 | 1850.2 | 73.3 | 0.047 | M3 | Figure 24 | | |
| | | E-Field with B | attery 2 | | | | |
| Low/512 | 1850.2 | 72.3 | -0.015 | M3 | Figure 25 | | |
| | · | H-Field with B | attery 1 | | | | |
| Channel | Frequency (MHz) | Peak Field (A/m) | Power Drift (dB) | Rating | Graph Results | | |
| High/810 | 1909.8 | 0.183 | 0.055 | M3 | Figure 26 | | |
| Middle/661 | 1880 | 0.198 | -0.073 | M3 | Figure 27 | | |
| Low/512 | 1850.2 | 0.225 | -0.025 | M3 | Figure 28 | | |
| | | H-Field with B | attery 2 | | · | | |
| Low/512 | 1850.2 | 0.219 | -0.010 | M3 | Figure 29 | | |

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4. Measurement Uncertainty

| | | | Uncertainty | Prob. | | | | Standard Uncertainty | Standard Uncertainty | Degree of |
|------|-----------------------------------|------|-------------|-------|------------|-------------------|-------------------|-------------------------|-------------------------|---|
| No. | Error source | Туре | Value (%) | Dist. | k | c _{i/} E | c _{i∖} H | (%) u _i (%) | (%) u _i (%) | freedom V _{eff} or <i>v</i> i |
| | | | | | | | | E | н | |
| | | | | Measu | rement | System | 1 | 1 | | |
| 1 | Probe Calibration | В | 5.1 | Ν | 1 | 1 | 1 | 5.1 | 5.1 | ∞ |
| 2 | Axial Isotropy | В | 4.7 | R | $\sqrt{3}$ | 1 | 1 | 2.7 | 2.7 | ∞ |
| 3 | Sensor Displacement | В | 16.5 | R | $\sqrt{3}$ | 1 | 0.145 | 9.5 | 1.4 | 8 |
| 4 | Boundary Effects | В | 2.4 | R | $\sqrt{3}$ | 1 | 1 | 1.4 | 1.4 | ∞ |
| 5 | Test Arch | В | 7.2 | R | $\sqrt{3}$ | 1 | 0 | 4.1 | 0 | ∞ |
| 6 | Linearity | В | 4.7 | R | $\sqrt{3}$ | 1 | 1 | 2.7 | 2.7 | 8 |
| 7 | Scaling to Peak Envelope Power | В | 2.0 | R | $\sqrt{3}$ | 1 | 1 | 1.2 | 1.2 | ∞ |
| 8 | System Detection Limit | В | 1.0 | R | $\sqrt{3}$ | 1 | 1 | 0.6 | 0.6 | ∞ |
| 9 | Readout Electronics | В | 0.3 | Ν | 1 | 1 | 1 | 0.3 | 0.3 | ∞ |
| 10 | Response Time | В | 0.8 | R | $\sqrt{3}$ | 1 | 1 | 0.5 | 0.5 | 8 |
| 11 | Integration Time | В | 2.6 | R | $\sqrt{3}$ | 1 | 1 | 1.5 | 1.5 | ∞ |
| 12 | RF Ambient Conditions | В | 3.0 | R | $\sqrt{3}$ | 1 | 1 | 1.7 | 1.7 | ∞ |
| 13 | RF Reflections | В | 12.0 | R | $\sqrt{3}$ | 1 | 1 | 6.9 | 6.9 | ∞ |
| 14 | Probe Positioner | В | 1.2 | R | $\sqrt{3}$ | 1 | 0.67 | 0.7 | 0.5 | 8 |
| 15 | Probe Positioning | A | 4.7 | R | $\sqrt{3}$ | 1 | 0.67 | 2.7 | 1.8 | ∞ |
| 16 | Extra. And Interpolation | В | 1.0 | R | $\sqrt{3}$ | 1 | 1 | 0.6 | 0.6 | ∞ |
| Test | Test Sample Related | | | | | | | | | |
| 17 | Device Positioning Vertical | В | 4.7 | R | $\sqrt{3}$ | 1 | 0.67 | 2.7 | 1.8 | ∞ |
| 18 | Device Positioning Lateral | В | 1.0 | R | $\sqrt{3}$ | 1 | 1 | 0.6 | 0.6 | ∞ |

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| 19 | Device Holder and Phantom | В | 2.4 | R | $\sqrt{3}$ | 1 | 1 | 1.4 | 1.4 | ∞ |
|------|--|------------|-----|--------|------------|---------|-------|-------|-------|---|
| 20 | Power Drift | В | 5.0 | R | $\sqrt{3}$ | 1 | 1 | 2.9 | 2.9 | ∞ |
| | | | P | hantom | and Set | up rela | ted | | | |
| 21 | Phantom Thickness | В | 2.4 | R | $\sqrt{3}$ | 1 | 0.67 | 1.4 | 0.9 | ∞ |
| Com | Combined standard uncertainty (%) | | | | | | 15.19 | 10.82 | | |
| Expa | Expanded Std. uncertainty on power (K=2) | | | | | | 30.38 | 21.65 | | |
| Expa | nded Std. uncertainty or | n field (K | =2) | | | | | 15.19 | 10.82 | |

5. Main Test Instruments

| No. | Name | Туре | Serial Number | Calibration Date | Valid Period |
|-----|------------------------|----------------|------------------|--------------------|--------------|
| 01 | Power meter | Agilent E4417A | GB41291714 | March 11, 2012 | One year |
| 02 | Power sensor | Agilent N8481H | MY50350004 | September 25, 2011 | One year |
| 03 | Signal Generator | HP 8341B | 2730A00804 | September 12, 2011 | One year |
| 04 | Amplifier | IXA-020 | 0401 | No Calibration R | equested |
| 05 | BTS | E5515C | MY48360988 | December 2, 2011 | One year |
| 06 | E-Field Probe | ER3DV6 | 2303 | February 21, 2012 | One year |
| 07 | H-Field Probe | H3DV6 | 6138 | February 21, 2012 | One year |
| 08 | DAE | DAE4 | 1317 | January 23, 2012 | One year |
| 09 | Validation Kit 835MHz | CD835V3 | 1133 | February 21, 2012 | One year |
| 10 | Validation Kit 1880MHz | CD1880V3 | 1115 | February 21, 2012 | One year |
| 11 | Hygrothermograph | WS-1 | 64591 | September 28, 2011 | One year |

*****END OF REPORT BODY*****

ANNEX A: System Check Results

HAC_System Performance Check at 835MHz_E

DUT: Dipole 835 MHz; Type: CD835V3; SN:1133 Date/Time: 5/7/2012 10:55:46 PM Communication System: CW; Frequency: 835 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: ER3DV6 - SN2303; ConvF(1, 1, 1); Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - measurement distance from the probe sensor center to CD835 Dipole =

10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 166.3 V/m

Probe Modulation Factor = 1.00

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 114.7 V/m; Power Drift = -0.053 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

 Peak E-field in V/m

 Grid 1
 Grid 2
 Grid 3

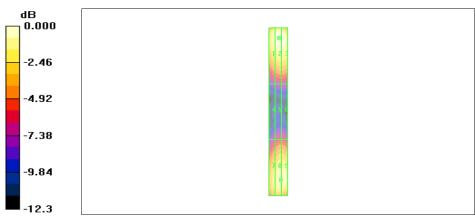
 154.3 M4
 166.3 M4
 163.7 M4

 Grid 4
 Grid 5
 Grid 6

 77.5 M4
 84.7 M4
 84.7 M4

 Grid 7
 Grid 8
 Grid 9

 138.5 M4
 152.1 M4
 152.0 M4



0 dB = 166.3V/m



HAC_System Performance Check at 835MHz_H

DUT: Dipole 835 MHz; Type: CD835V3; SN: 1133

Date/Time: 5/7/2012 10:23:56 AM Communication System: CW; Frequency: 835 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - measurement distance from the probe sensor center to CD835 Dipole =

10mm/Hearing Aid Compatibility Test (41x381x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.473 A/m

Peak H-field in A/m

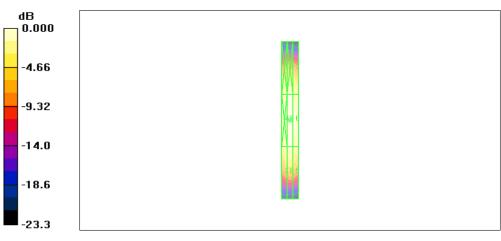
Probe Modulation Factor = 1.00

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.504 A/m; Power Drift = -0.009 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

| Grid 1 | Grid 2 | Grid 3 | | | | | |
|----------|----------|----------|--|--|--|--|--|
| 0.394 M4 | 0.412 M4 | 0.390 M4 | | | | | |
| Grid 4 | Grid 5 | Grid 6 | | | | | |
| 0.450 M4 | 0.473 M4 | 0.447 M4 | | | | | |
| Grid 7 | Grid 8 | Grid 9 | | | | | |
| 0.387 M4 | 0.412 M4 | 0.392 M4 | | | | | |



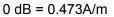


Figure 9 System Performance Check 835MHz_H

HAC_System Performance Check at 835MHz_H

DUT: Dipole 835 MHz; Type: CD835V3; SN: 1133

Date/Time: 5/8/2012 11:56:54 AM Communication System: CW; Frequency: 835 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - measurement distance from the probe sensor center to CD835 Dipole =

10mm/Hearing Aid Compatibility Test (41x381x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.466 A/m

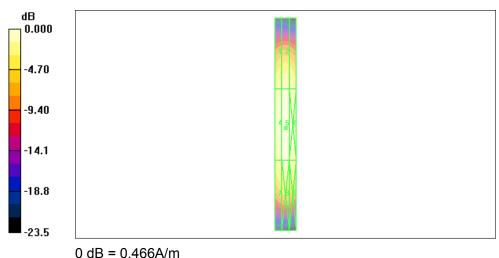
Probe Modulation Factor = 1.00

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.498 A/m; Power Drift = -0.042 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

| Peak H-field in A/m | | |
|---------------------|---------------|----------|
| Grid 1 | Grid 2 Grid 3 | |
| 0.381 M4 | 0.401 M4 | 0.382 M4 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.440 M4 | 0.466 M4 | 0.446 M4 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.386 M4 | 0.412 M4 | 0.394 M4 |







HAC_System Performance Check at 1880MHz_E

DUT: Dipole 1880 MHz; Type: CD1880V3; SN: 1115

Date/Time: 5/8/2012 11:40:35 AM Communication System: CW; Frequency: 1880 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: ER3DV6 - SN2303; ConvF(1, 1, 1); Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - measurement distance from the probe sensor center to CD1880 Dipole =

10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Peak E-field in V/m

Maximum value of peak Total field = 140.9 V/m

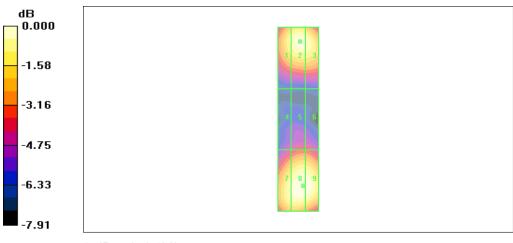
Probe Modulation Factor = 1.00

Device Reference Point: 0.000, 0.000, -6.30 mm

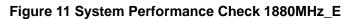
Reference Value = 143.8 V/m; Power Drift = -0.019 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 128.1 M2 | 137.1 M2 | 134.2 M2 |
| Grid 4 | Grid 5 | Grid 6 |
| 85.7 M3 | 92.4 M3 | 92.2 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| 132.5 M2 | 140.9 M2 | 140.5 M2 |



0 dB = 140.9V/m



HAC_System Performance Check at 1880MHz_H

DUT: Dipole 1880 MHz; Type: CD1880V3; SN: 1115

Date/Time: 5/7/2012 10:13:09 AM Communication System: CW; Frequency: 1880 MHz;Duty Cycle: 1:1 Medium parameters used: σ = 0 mho/m, ϵ_r = 1; ρ = 1 kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section DASY4 Configuration:

Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012

Electronics: DAE4 Sn1317; Calibrated: 1/23/2012

Phantom: HAC Test Arch; Type: SD HAC P01 BA

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Peak H-field in A/m

H Scan - measurement distance from the probe sensor center to Dipole = 10mm/Hearing Aid

Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.463 A/m

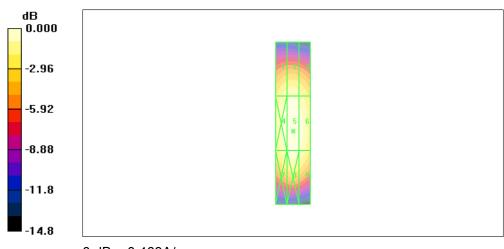
Probe Modulation Factor = 1.00

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.489 A/m; Power Drift = 0.011 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 0.398 M2 | 0.412 M2 | 0.393 M2 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.444 M2 | 0.463 M2 | 0.441 M2 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.418 M2 | 0.441 M2 | 0.417 M2 |



0 dB = 0.463A/m



HAC_System Performance Check at 1880MHz_H

DUT: Dipole 1880 MHz; Type: CD1880V3; SN: 1115

Date/Time: 5/8/2012 11:48:40 AM Communication System: CW; Frequency: 1880 MHz;Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Peak H-field in A/m

H Scan - measurement distance from the probe sensor center to Dipole = 10mm/Hearing Aid

Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.459 A/m

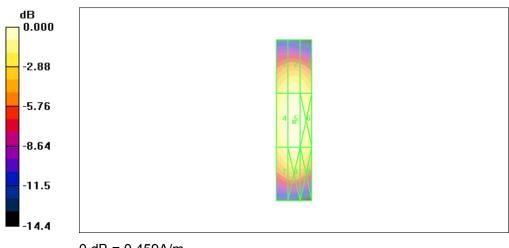
Probe Modulation Factor = 1.00

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.487 A/m; Power Drift = 0.021 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 0.399 M2 | 0.418 M2 | 0.402 M2 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.438 M2 | 0.459 M2 | 0.441 M2 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.408 M2 | 0.429 M2 | 0.408 M2 |



0 dB = 0.459A/m



ANNEX B: Graph Results

HAC RF E-Field GSM 850 High (Battery 1)

Date/Time: 5/8/2012 11:05:57 AM Communication System: GSM850; Frequency: 848.8 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: ER3DV6 - SN2303; ConvF(1, 1, 1); Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

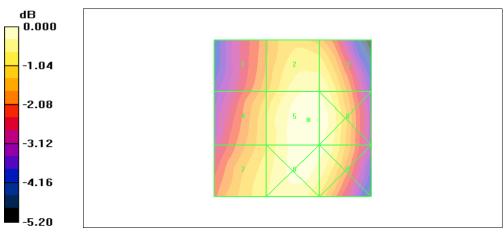
E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 181.1 V/m Probe Modulation Factor = 2.81 Device Reference Point: 0.000, 0.000, -6.30 mm Reference Value = 81.1 V/m; Power Drift = 0.073 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 153.2 M3 | 174.7 M3 | 174.0 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 160.8 M3 | 181.1 M3 | 179.5 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| 166.8 M3 | 179.0 M3 | 176.9 M3 |

Peak E-field in V/m



0 dB = 181.1V/m



HAC RF E-Field GSM 850 Middle (Battery 1)

Date/Time: 5/8/2012 11:01:09 AM Communication System: GSM850; Frequency: 836.6 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: ER3DV6 - SN2303; ConvF(1, 1, 1); Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 185.5 V/m

Probe Modulation Factor = 2.81

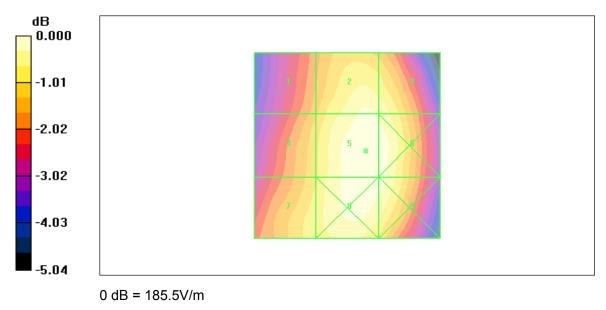
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 83.7 V/m; Power Drift = -0.024 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

| Peak E-field | in | V/m |
|--------------|----|-----|
|--------------|----|-----|

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 157.6 M3 | 180.2 M3 | 177.4 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 164.8 M3 | 185.5 M3 | 184.2 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| 169.6 M3 | 184.0 M3 | 181.8 M3 |





HAC RF E-Field GSM 850 Low (Battery 1)

Date/Time: 5/8/2012 11:12:36 AM Communication System: GSM850; Frequency: 824.2 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: ER3DV6 - SN2303; ConvF(1, 1, 1); Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 189.8 V/m

Probe Modulation Factor = 2.81

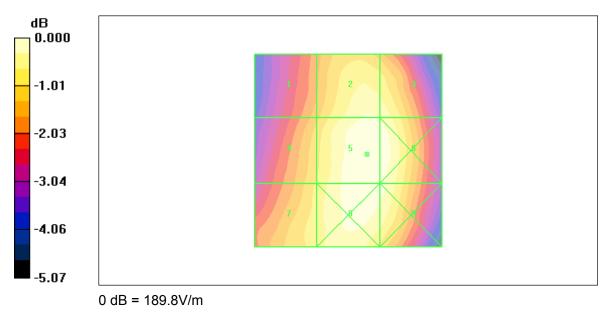
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 85.5 V/m; Power Drift = 0.043 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

| Peak E-field in | n V/m |
|-----------------|-------|
|-----------------|-------|

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 160.5 M3 | 183.5 M3 | 181.8 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 169.7 M3 | 189.8 M3 | 188.7 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| 173.0 M3 | 189.2 M3 | 185.7 M3 |





HAC RF E-Field GSM 850 Low (Battery 2)

Date/Time: 5/8/2012 11:20:45 AM Communication System: GSM850; Frequency: 824.2 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: ER3DV6 - SN2303; ConvF(1, 1, 1); Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 190.6 V/m

Probe Modulation Factor = 2.81

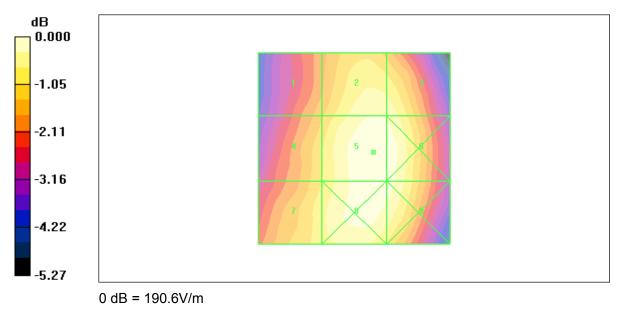
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 85.7 V/m; Power Drift = 0.013 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

| Peak E-field in V/m | | | |
|---------------------|---------------|----------|--|
| Grid 1 | Grid 2 Grid 3 | | |
| 161.0 M3 | 183.4 M3 | 181.8 M3 | |
| Grid 4 | Grid 5 | Grid 6 | |
| 169.0 M3 | 190.6 M3 | 188.8 M3 | |

Grid 7 Grid 8 Grid 9 173.5 M3 188.2 M3 186.6 M3





HAC RF H-Field GSM 850 High (Battery 1)

Date/Time: 5/7/2012 9:59:43 PM Communication System: GSM850; Frequency: 848.8 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.251 A/m

Probe Modulation Factor = 2.75

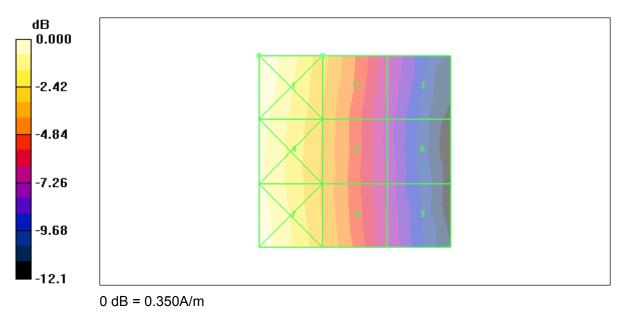
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.071 A/m; Power Drift = 0.005 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

| Peak H-field | in A/m |
|--------------|--------|
|--------------|--------|

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 0.350 M4 | 0.251 M4 | 0.157 M4 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.332 M4 | 0.241 M4 | 0.150 M4 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.339 M4 | 0.245 M4 | 0.154 M4 |



HAC RF H-Field GSM 850 Middle (Battery 1)

Date/Time: 5/7/2012 9:54:50 PM Communication System: GSM850; Frequency: 836.6 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.250 A/m

Probe Modulation Factor = 2.75

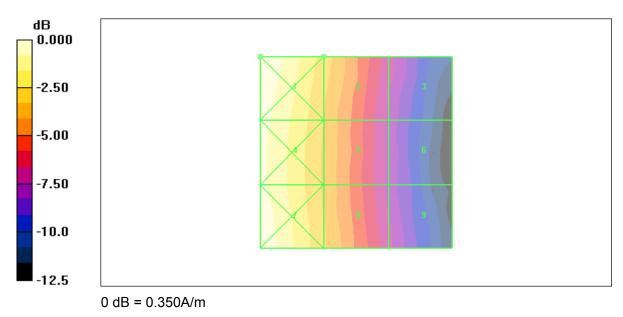
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.070 A/m; Power Drift = 0.057 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 0.350 M4 | 0.250 M4 | 0.155 M4 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.332 M4 | 0.239 M4 | 0.146 M4 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.341 M4 | 0.242 M4 | 0.153 M4 |



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| Test Report | |

HAC RF H-Field GSM 850 Low (Battery 1)

Date/Time: 5/7/2012 10:10:27 PM Communication System: GSM850; Frequency: 824.2 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.247 A/m

Probe Modulation Factor = 2.75

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.069 A/m; Power Drift = 0.001 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 0.348 M4 | 0.247 M4 | 0.157 M4 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.331 M4 | 0.235 M4 | 0.145 M4 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.340 M4 | 0.240 M4 | 0.150 M4 |

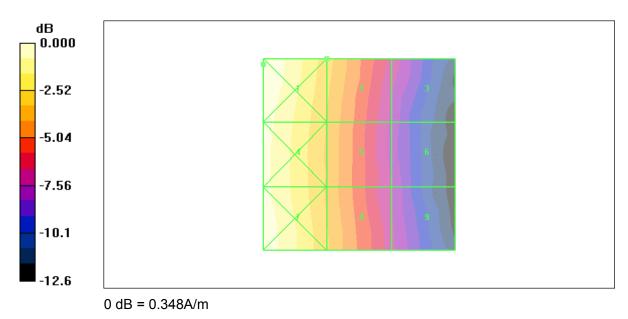


Figure 20 HAC RF H-Field GSM 850 Channel 128

| TA Technology (Shanghai) (| Со., | Ltd. |
|----------------------------|------|------|
| Test Report | | |

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HAC RF H-Field GSM 850 High (Battery 2)

Date/Time: 5/8/2012 12:06:59 PM Communication System: GSM850; Frequency: 848.8 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.256 A/m

Probe Modulation Factor = 2.75

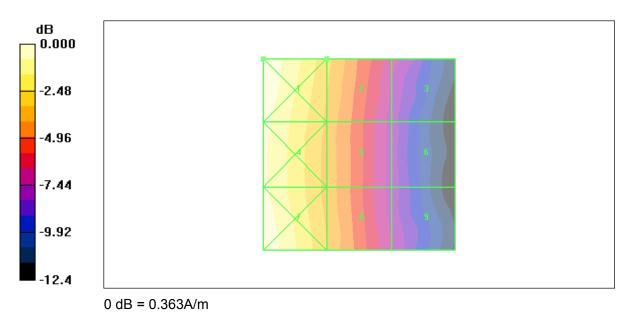
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.072 A/m; Power Drift = -0.077 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 0.363 M4 | 0.256 M4 | 0.163 M4 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.341 M4 | 0.243 M4 | 0.149 M4 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.357 M4 | 0.250 M4 | 0.156 M4 |



HAC RF E-Field GSM 1900 High (Battery 1)

Date/Time: 5/8/2012 12:45:57 PM Communication System: PCS 1900; Frequency: 1909.8 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: ER3DV6 - SN2303; ConvF(1, 1, 1); Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 69.6 V/m

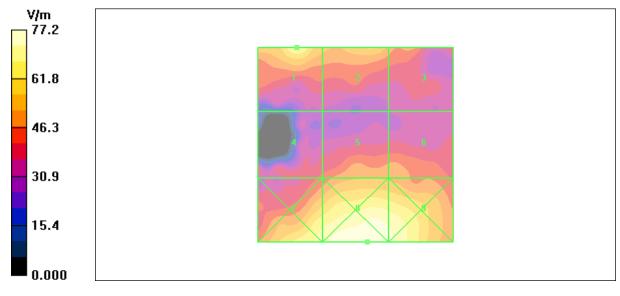
Probe Modulation Factor = 2.84

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 12.7 V/m; Power Drift = 0.015 dB

| Peak E-field i | n V/m |
|----------------|-------|
|----------------|-------|

| Grid 1 | Grid 2 | Grid 3 |
|---------|---------|---------|
| 69.6 M3 | 58.1 M3 | 49.6 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 42.8 M4 | 51.8 M3 | 50.8 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| 70.0 M3 | 77.2 M3 | 73.4 M3 |



HAC RF E-Field GSM 1900 Middle (Battery 1)

Date/Time: 5/8/2012 12:40:06 PM Communication System: PCS 1900; Frequency: 1880 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: ER3DV6 - SN2303; ConvF(1, 1, 1); Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 67.3 V/m

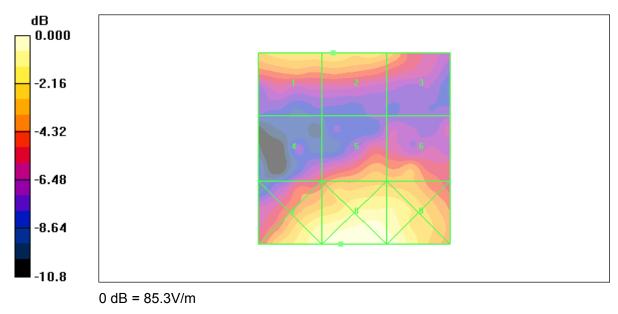
Probe Modulation Factor = 2.84

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 13.8 V/m; Power Drift = -0.090 dB

| Peak B | E-field | in ' | V/m |
|--------|---------|------|-----|
|--------|---------|------|-----|

| Grid 1 | Grid 2 | Grid 3 |
|---------|---------|---------|
| 65.3 M3 | 67.3 M3 | 60.5 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 48.0 M3 | 59.6 M3 | 58.8 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| 78.0 M3 | 85.3 M2 | 83.4 M3 |





HAC RF E-Field GSM 1900 Low (Battery 1)

Date/Time: 5/8/2012 12:50:57 PM Communication System: PCS 1900; Frequency: 1850.2 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: ER3DV6 - SN2303; ConvF(1, 1, 1); Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

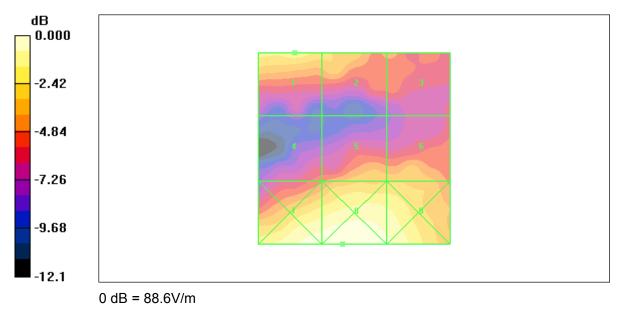
Maximum value of peak Total field = 73.3 V/m

Probe Modulation Factor = 2.84

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 14.0 V/m; Power Drift = 0.047 dB

| Grid 1 | Grid 2 | Grid 3 |
|---------|---------|---------|
| 73.3 M3 | 63.7 M3 | 53.1 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 49.7 M3 | 60.4 M3 | 60.5 M3 |
| | Crid Q | Grid 9 |
| Grid 7 | Grid 8 | Ghu 9 |





HAC RF E-Field GSM 1900 Low (Battery 2)

Date/Time: 5/8/2012 12:58:56 PM Communication System: PCS 1900; Frequency: 1850.2 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: ER3DV6 - SN2303; ConvF(1, 1, 1); Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 72.3 V/m

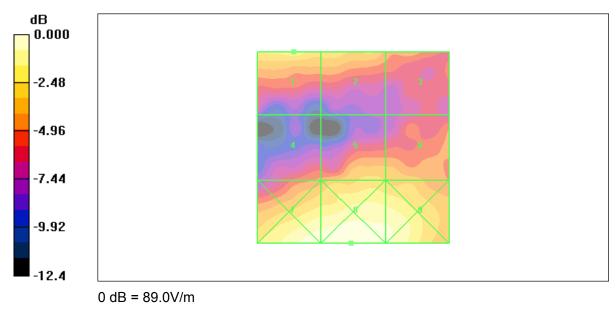
Probe Modulation Factor = 2.84

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 14.4 V/m; Power Drift = -0.015 dB

| Peak E-field i | n V/m |
|----------------|-------|
|----------------|-------|

| Grid 1 | Grid 2 | Grid 3 |
|---------|---------|---------|
| 72.3 M3 | 65.1 M3 | 54.7 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 52.0 M3 | 62.7 M3 | 60.4 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| | | 82.8 M3 |





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HAC RF H-Field GSM 1900 High (Battery 1)

Date/Time: 5/7/2012 10:21:01 PM Communication System: PCS 1900; Frequency: 1909.8 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.183 A/m

Probe Modulation Factor = 2.84

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.071 A/m; Power Drift = 0.055 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

| Peak | H-field | in A/m |
|------|---------|--------|
|------|---------|--------|

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 0.165 M3 | 0.183 M3 | 0.183 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.154 M3 | 0.183 M3 | 0.183 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.202 M3 | 0.166 M3 | 0.163 M3 |

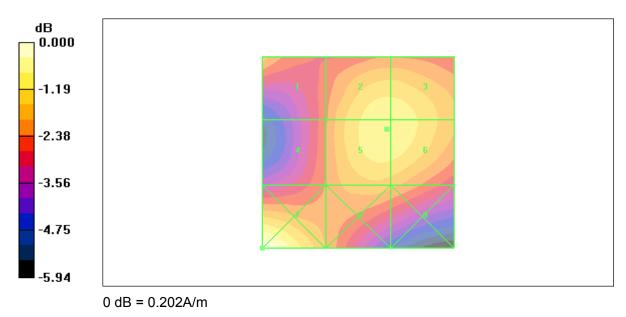


Figure 26 HAC RF H-Field GSM 1900 Channel 810

HAC RF H-Field GSM 1900 Middle (Battery 1)

Date/Time: 5/7/2012 10:15:59 PM Communication System: PCS 1900; Frequency: 1880 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.198 A/m

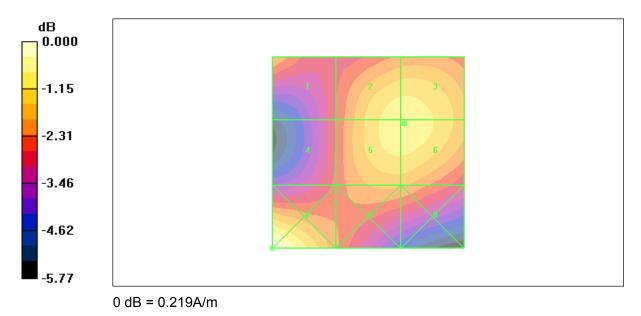
Probe Modulation Factor = 2.84

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.076 A/m; Power Drift = -0.073 dB

| Peak | H-field | in A/m |
|------|---------|--------|
|------|---------|--------|

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 0.178 M3 | 0.198 M3 | 0.198 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.163 M3 | 0.198 M3 | 0.198 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| | | |



HAC RF H-Field GSM 1900 Low (Battery 1)

Date/Time: 5/7/2012 10:25:53 PM Communication System: PCS 1900; Frequency: 1850.2 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.225 A/m

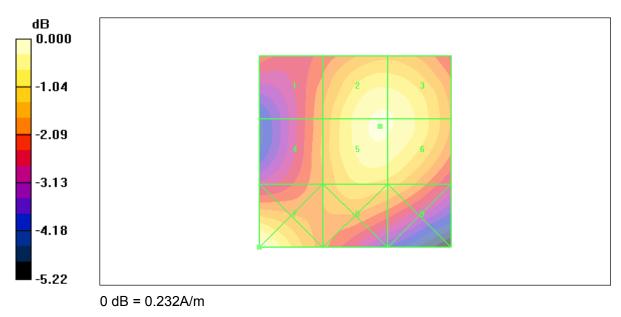
Probe Modulation Factor = 2.84

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.088 A/m; Power Drift = -0.025 dB

| Peak | H-field | in A/m |
|------|---------|--------|
|------|---------|--------|

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 0.191 M3 | 0.225 M3 | 0.224 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.192 M3 | 0.225 M3 | 0.224 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| Ghu / | Onu o | Onu a |



HAC RF H-Field GSM 1900 Low (Battery 2)

Date/Time: 5/8/2012 12:22:20 PM Communication System: PCS 1900; Frequency: 1850.2 MHz;Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.3 °C Phantom section: RF Section DASY4 Configuration: Probe: H3DV6 - SN6138; ; Calibrated: 2/21/2012 Electronics: DAE4 Sn1317; Calibrated: 1/23/2012 Phantom: HAC Test Arch; Type: SD HAC P01 BA Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid

Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.219 A/m

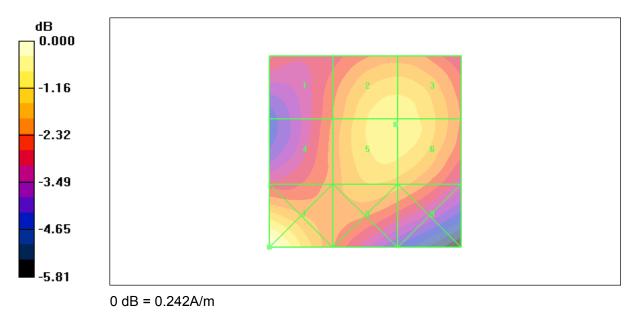
Probe Modulation Factor = 2.84

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.085 A/m; Power Drift = -0.010 dB

| Peak | H-field | in A/m |
|------|---------|--------|
|------|---------|--------|

| Grid 1 | Grid 2 | Grid 3 |
|----------|----------|----------|
| 0.186 M3 | 0.219 M3 | 0.219 M3 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.189 M3 | 0.219 M3 | 0.219 M3 |
| Grid 7 | Grid 8 | Grid 9 |
| | | 0.198 M3 |



ANNEX C: E-Probe Calibration Certificate Calibration Laboratory of SWISS Schweizerischer Kalibrierdienst S Schmid & Partner Service suisse d'étalonnage С Q RIBRAT Engineering AG Servizio svizzero di taratura s Zeughausstrasse 43, 8004 Zurich, Switzerland Swiss Calibration Service Accredited by the Swiss Accreditation Service (SAS) Accreditation No.: SCS 108 The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates TA Shanghai (Auden) Certificate No: ER3-2303 Feb12 Client **CALIBRATION CERTIFICATE** Object ER3DV6 - SN:2303 QA CAL-02.v6, QA CAL-25.v4 Calibration procedure(s) Calibration procedure for E-field probes optimized for close near field evaluations in air Calibration date: February 21, 2012 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)/C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards UD. Cal Date (Certificate No.) Scheduled Calibration Power meter E44198 GB41293874 31-Mar-11 (No. 217-01372) Apr-12 Power sensor E4412A MY41496087 31-Mar-11 (No. 217-01372) Apr-12 Reference 3 dB Attenuator SN: S5054 (3c) 29-Mar-11 (No. 217-01369) Apr-12 Reference 20 dB Attenuator SN: S5086 (20b) 29-Mar-11 (No. 217-01367) Apr-12 Reference 30 dB Attenuator SN: S5129 (305) 29-Mar-11 (No. 217-01370) Apr-12 Reference Probe ER3DV6 SN: 2328 11-Oct-11 (No. ER3-2328_Oct11) Oct-12 30-Jan-12 (No. DAE4-789_Jan12) DAE4 SN: 789 Jan-13 Secondary Standards D Check Date (in house) Scheduled Check RF generator HP 8648C US3642U01700 * 4-Aug-99 (in house check Apr-11) In house check: Apr-13 Network Analyzer HP 8753E US37390585 18-Oct-01 (in house check Oct-11) In house check: Oct-12 Function Name Signatur Calibrated by Claudio Leubler Laboratory Technician Katja Pokovic **Technical Manager** Approved by: issued: February 22, 2012 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: ER3-2303_Feb12

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Report No. RXA1204-0112HAC01

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



- S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage
 - Servizio svizzero di taratura Swiss Calibration Service

S

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

| 0100001. | |
|---------------------|---|
| NORMx,y,z | sensitivity in free space |
| DCP | diode compression point |
| CF | crest factor (1/duty_cycle) of the RF signal |
| A, B, C | modulation dependent linearization parameters |
| Polarization ϕ | φ rotation around probe axis |
| Polarization 9 | 9 rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., 9 = 0 is normal to probe axis |
| Connector Angle | information used in DASY system to align probe sensor X to the robot coordinate system |

Calibration is Performed According to the Following Standards:

 IEEE Std 1309-2005, * IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization 8 = 0 for XY sensors and 8 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z; A, B, C are numerical linearization parameters assessed based on the data of
 power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the
 maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe-tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

ER3DV6 - SN:2303

February 21, 2012

Probe ER3DV6

SN:2303

Manufactured: Calibrated:

.

November 6, 2002 February 21, 2012

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: ER3-2303_Feb12

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ER3DV6- SN:2303

February 21, 2012

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2303

Basic Calibration Parameters

| | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|-------------------------------|----------|----------|----------|-----------|
| Norm (µV/(V/m) ²) | 1.40 | 1.42 | 1.43 | ± 10.1 % |
| DCP (mV) ⁸ | 100.7 | 99.2 | 104.7 | |

Modulation Calibration Parameters

| UID | Communication System Name | PAR | | A dB | B dB | C dB | VR mV | Unc ^E (k=2) |
|-------|---------------------------|------|---|---------|---------|---------|----------|---------------------------|
| 10000 | CW | 0.00 | X | 0.00 | 0.00 | 1.00 | 111.4 | ±3.0 % |
| | | | Y | 0.00 | 0.00 | 1.00 | 139.9 | |
| | | | Z | 0.00 | 0.00 | 1.00 | 133.1 | |

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

⁶ Numerical linearization parameter: uncertainty not required.
⁶ Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Certificate No: ER3-2303_Feb12

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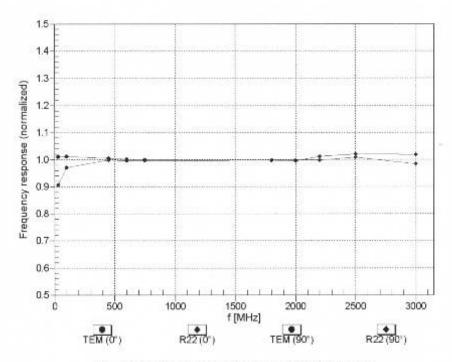
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ER3DV6- SN:2303

February 21, 2012

Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Certificate No: ER3-2303_Feb12

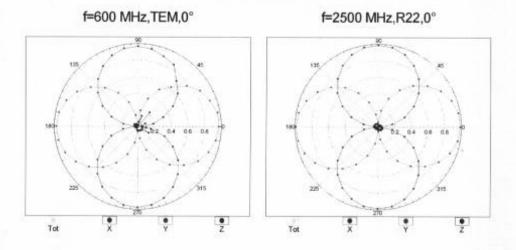
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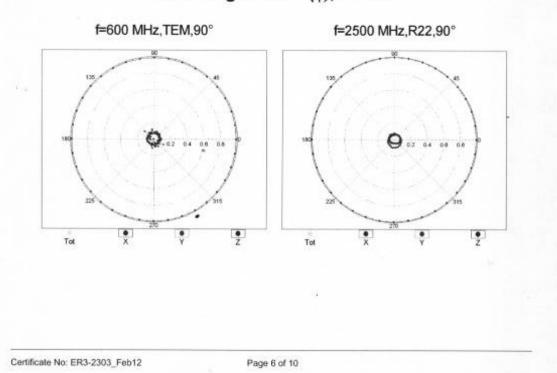
ER3DV6- SN:2303

February 21, 2012

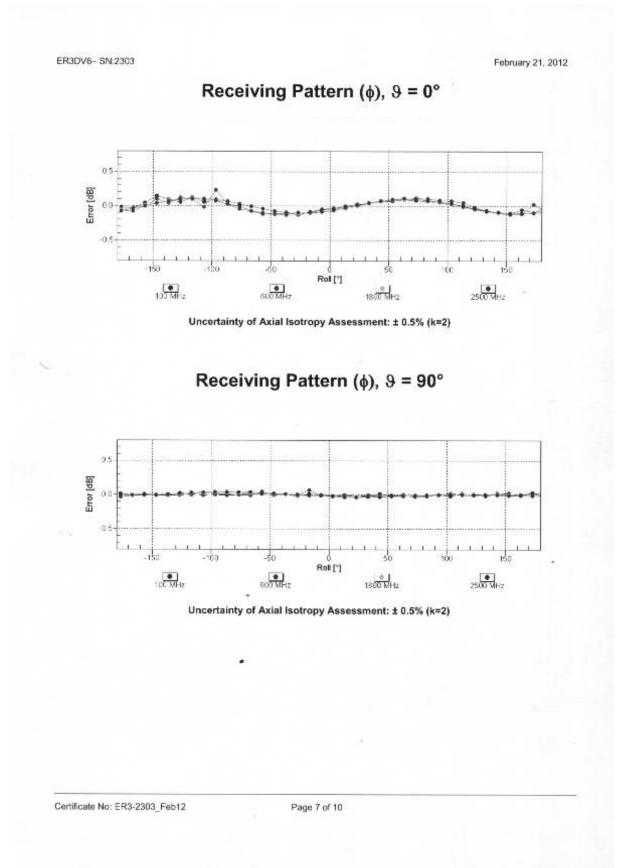
Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Receiving Pattern (ϕ), ϑ = 90°

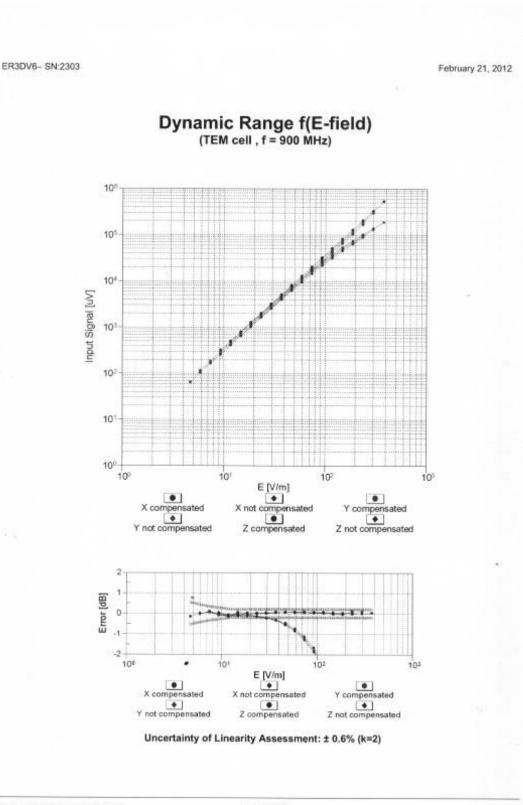


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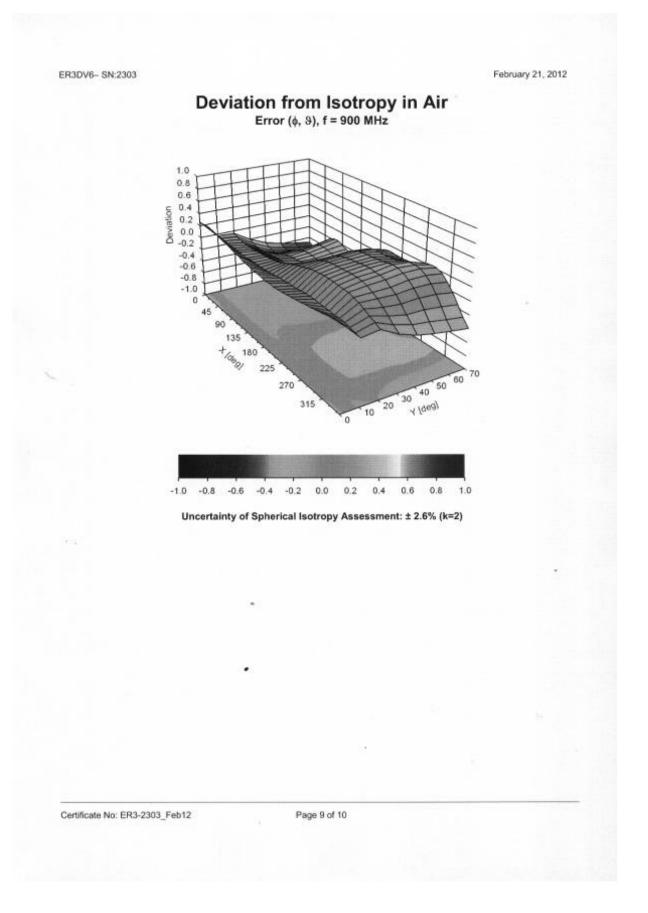


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ER3DV6-- SN:2303

February 21, 2012

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2303

Other Probe Parameters

| Sensor Arrangement | Rectangular |
|---|-------------|
| Connector Angle (*) | -156.8 |
| Mechanical Surface Detection Mode | enabled |
| Optical Surface Detection Mode | disabled |
| Probe Overall Length | 337 mm |
| Probe Body Diameter | 10 mm |
| Tip Length | 10 mm |
| Tip Diameter | 8 mm |
| Probe Tip to Sensor X Calibration Point | 2.5 mm |
| Probe Tip to Sensor Y Calibration Point | 2.5 mm |
| Probe Tip to Sensor Z Calibration Point | 2.5 mm |

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ANNEX D: H-Probe Calibration Certificate Calibration Laboratory of SWISS Schweizerischer Kalibrierdienst s Schmid & Partner Service suisse d'étalonnage С 0 ac-MR/ RIARAT Engineering AG Servizio svizzero di taratura s Zeughausstrasse 43, 8004 Zurich, Switzerland Swiss Calibration Service Accreditation No.: SCS 108 Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Certificate No: H3-6138_Feb12 TA Shanghai (Auden) Client CALIBRATION CERTIFICATE Object H3DV6 - SN:6138 QA CAL-03.v6, QA CAL-25.v4 Calibration procedure(s) Calibration procedure for H-field probes optimized for close near field evaluations in air Calibration date: February 21, 2012 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards Cal Date (Certificate No.) Scheduled Calibration iD Power meter E44198 GB41293874 31-Mar-11 (No. 217-01372) Apr-12 Power sensor E4412A MY41498087 31-Mar-11 (No. 217-01372) Apr-12 Reference 3 dB Attenuator SN: S5054 (3c) 29-Mar-11 (No. 217-01369) Apr-12 Reference 20 dB Attenuator SN: S5086 (20b) 29-Mar-11 (No. 217-01367) Apr-12 Reference 30 dB Attenuator SN: S5129 (30b) 29-Mar-11 (No. 217-01370) Apr-12 Reference Probe H3DV6 SN: 6182 11-Oct-11 (No. H3-6182_Oct11) Oct-12 DAE4 SN: 789 30-Jan-12 (No. DAE4-789_Jan12) Jan-13 Secondary Standards ID. Check Date (in house) Scheduled Check RF generator HP 8648C US3642U01700 4-Aug-99 (in house check Apr-11) in house check: Apr-13 Network Analyzer HP 8753E U\$37390585 18-Oct-01 (in house check Oct-11) In house check: Oct-12 Name Function Calibrated by: Claudio Leubler Laboratory Technician Technical Manager Approved by: Katja Pokovic Issued: February 23, 2012 This calibration certificate shall not be reproduced except in full without written approval of the laboratory

Certificate No: H3-6138_Feb12

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Report No. RXA1204-0112HAC01

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



- Schweizerischer Kalibrierdienst S Service suisse d'étalonnage
- C Servizio svizzero di taratura S
 - Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

| NORMx,y,z | sensitivity in free space |
|---------------------|---|
| DCP | diode compression point |
| CF | crest factor (1/duty_cycle) of the RF signal |
| A, B, C | modulation dependent linearization parameters |
| Polarization ϕ | φ rotation around probe axis |
| Polarization 9 | 9 rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., 9 = 0 is normal to probe axis |
| Connector Angle | information used in DASY system to align probe sensor X to the robot coordinate system |

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-2005, " IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 for XY sensors and 9 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- X,Y,Z(f)_a0a1a2= X,Y,Z_a0a1a2* frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the X_a0a1a2 (no uncertainty required).



H3DV6 - SN:6138

February 21, 2012

Probe H3DV6

SN:6138

Manufactured: Calibrated: July 3, 2002 February 21, 2012

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: H3-6138_Feb12

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H3DV6- SN:6138

February 21, 2012

DASY/EASY - Parameters of Probe: H3DV6 - SN:6138

Basic Calibration Parameters

| | | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|-----------------------|----|------------|------------|------------|-----------|
| Norm (A/m / √(mV)) | a0 | 2.73E-003 | 2.93E-003 | 3.18E-003 | ± 5,1 % |
| Norm (A/m / √(mV)) | a1 | -5.89E-005 | -2.38E-004 | -2.18E-004 | ± 5.1 % |
| Norm (A/m / √(mV)) | a2 | -5.50E-006 | -3.95E-006 | -8.28E-007 | ± 5.1 % |
| DCP (mV) ⁸ | | 93.5 | 92.1 | 94.8 | |

Modulation Calibration Parameters

| UID | Communication System Name | PAR | | A dB | B dB | C dB | VR mV | Unc ^E (k=2) |
|-------|---------------------------|------|---|---------|---------|---------|----------|---------------------------|
| 10000 | CW | 0.00 | X | 0.00 | 0.00 | 1.00 | 130.7 | ±3.3 % |
| | | | Y | 0.00 | 0.00 | 1.00 | 125.5 | |
| | | | Z | 0.00 | 0.00 | 1.00 | 133.0 | |

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

⁶ Numerical linearization parameter: uncertainty not required.
⁶ Uncertainty is determined using the max, deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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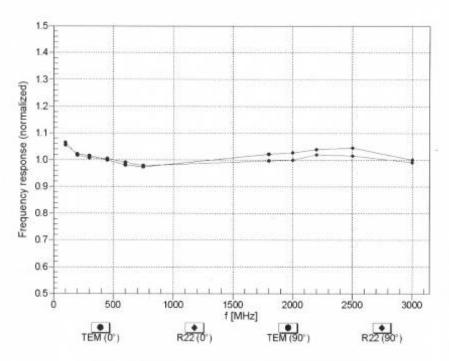
Report No. RXA1204-0112HAC01

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H3DV6- SN:6138

February 21, 2012

Frequency Response of H-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of H-field: ± 6.3% (k=2)

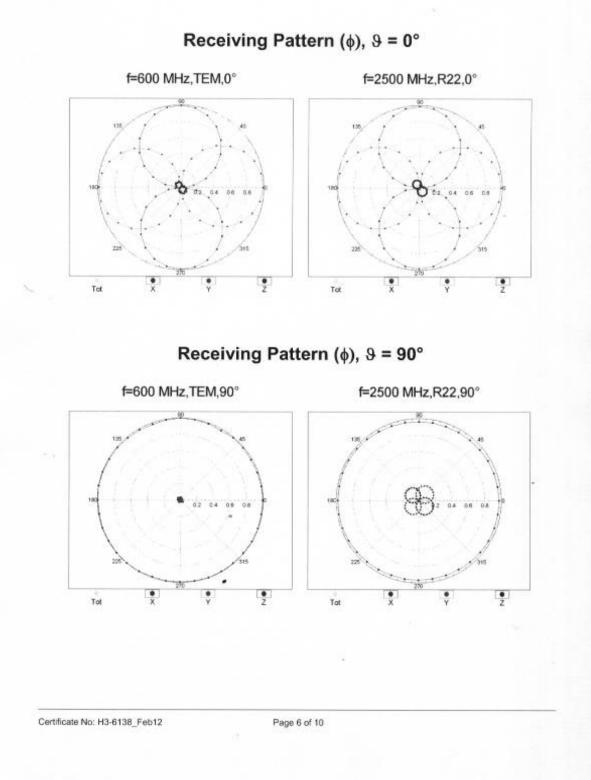
Certificate No: H3-6138_Feb12

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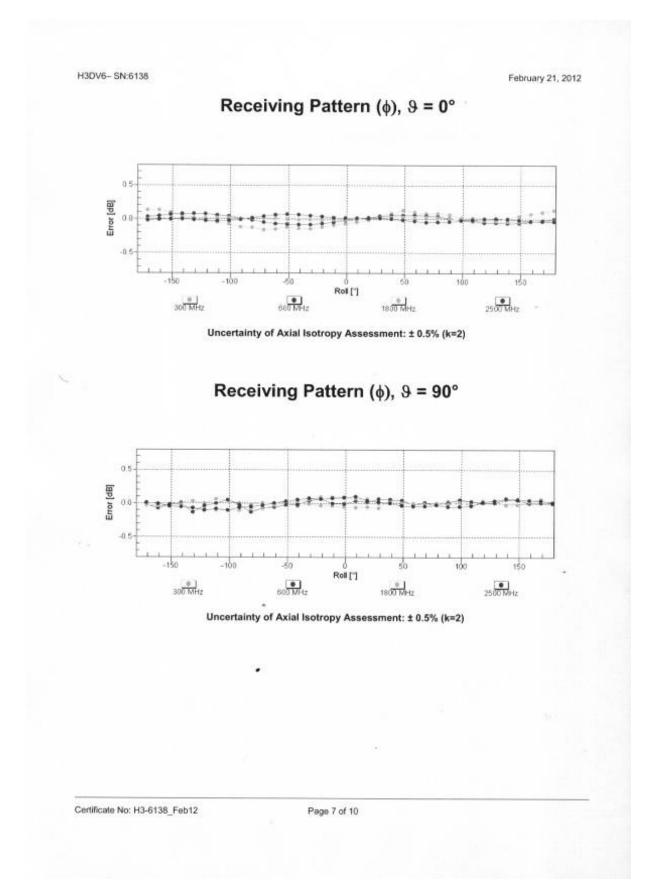
Report No. RXA1204-0112HAC01

H3DV6- SN:6138

February 21, 2012



Report No. RXA1204-0112HAC01

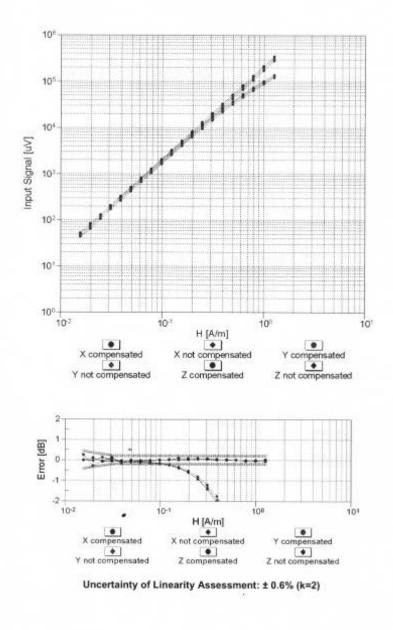


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H3DV6- SN:6138

February 21, 2012

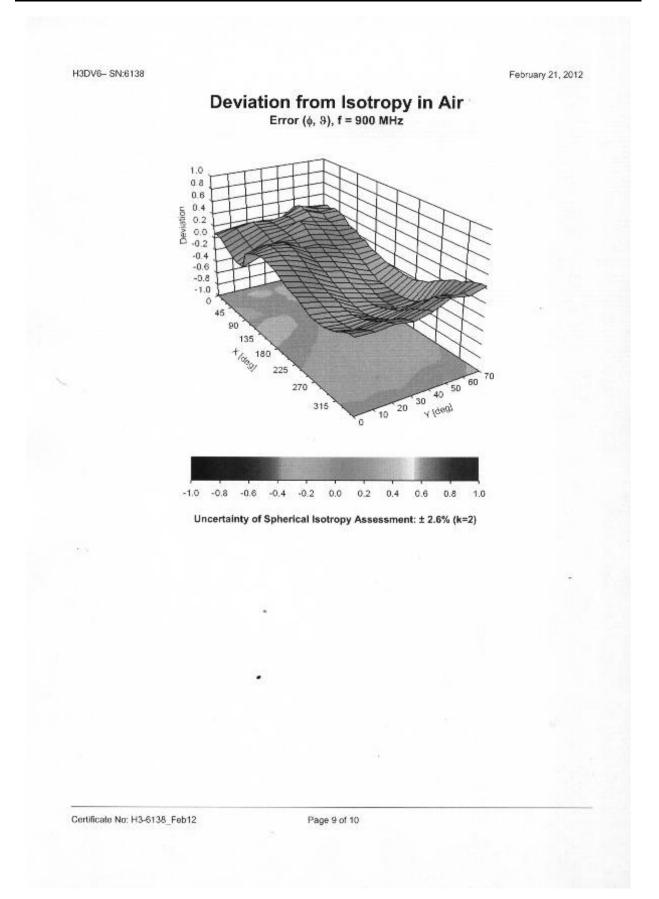
Dynamic Range f(H-field) (TEM cell, f = 900 MHz)



Certificate No: H3-6138_Feb12

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H3DV6- SN:6138

February 21, 2012

DASY/EASY - Parameters of Probe: H3DV6 - SN:6138

Other Probe Parameters

| Sensor Arrangement | Rectangular |
|---|-------------|
| Connector Angle (°) | 168.6 |
| Mechanical Surface Detection Mode | enabled |
| Optical Surface Detection Mode | disabled |
| Probe Overall Length | 337 mm |
| Probe Body Diameter | 10 mm |
| Tip Length | 20 mm |
| Tip Diameter | 6 mm |
| Probe Tip to Sensor X Calibration Point | 3 mm |
| Probe Tip to Sensor Y Calibration Point | 3 mm |
| Probe Tip to Sensor Z Calibration Point | 3 mm |

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ANNEX E: CD835V3 Dipole Calibration Certificate

| Engineering AG cughausstrasse 43, 8004 Zuri | ch, Switzerland | Hac-MRA (CU Z | S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service |
|---|---|--|---|
| ccredited by the Swiss Accredit he Swiss Accreditation Servic ultilateral Agreement for the r | e is one of the signatorie | Accreditation | on No.: SCS 108 |
| ient TA Shanghai (| | Contraction of Contra | No: CD835V3-1133_Feb12 |
| CALIBRATION | CERTIFICAT | E | |
| Object | CD835V3 - SN: | 1133 | the second second second |
| Calibration procedure(s) | QA CAL-20.v6 Calibration proc | edure for dipoles in air | • |
| Calibration date: | February 21, 20 | 12 | |
| | | | |
| The measurements and the uno | ertainties with confidence (| tional standards, which realize the physical u probability are given on the following pages ory facility: environment temperature (22 ± 3) | and are part of the certificate. |
| The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 | ertainties with confidence ucted in the closed laborate kTE critical for calibration) | probability are given on the following pages | and are part of the certificate. |
| The measurements and the unc All calibrations have been condu Calibration Equipment used (M& Primary Standards | ertainties with confidence ucted in the closed laborate kTE critical for calibration) | probability are given on the following pages ory facility: environment temperature (22 ± 3) Cal Date (Certificate No.) | and are part of the certificate.)°C and humidity < 70%. Scheduled Calibration |
| The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter EPM-442A | ertainties with confidence ucted in the closed laborate kTE critical for calibration) ID # GB37480704 | probability are given on the following pages ory facility: environment temperature (22 ± 3) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) | and are part of the certificate.)°C and humidity < 70%. Scheduled Calibration Oct-12 |
| The measurements and the unc All calibrations have been condi Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP B481A | ertainties with confidence ucted in the closed laborate RTE critical for calibration) ID # GB37480704 US37292783 | probability are given on the following pages ory facility: environment temperature (22 ± 3) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) | and are part of the certificate. VC and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Oct-12 |
| The measurements and the unc All calibrations have been condu Calibration Equipment used (M& Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 | ertainties with confidence ucted in the closed laborate kTE critical for calibration) ID # GB37480704 | probability are given on the following pages ory facility: environment temperature (22 ± 3) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) | and are part of the certificate.)°C and humidity < 70%. Scheduled Calibration Oct-12 |
| The measurements and the unc All calibrations have been condu Calibration Equipment used (M& Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 | ertainties with confidence ucted in the closed laborato RTE critical for calibration) ID # GB37480704 US37292783 SN: 2335 | probability are given on the following pages ory facility: environment temperature (22 ± 3) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) | and are part of the certificate. VC and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 |
| The measurements and the uno All calibrations have been condu Calibration Equipment used (M& Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 | ertainties with confidence ucted in the closed laborato kTE critical for calibration) ID # GB37480704 US37292783 SN: 2335 SN: 6065 | Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) | and are part of the certificate. VC and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Oct-12 Dec-12 Dec-12 - |
| The measurements and the uno All calibrations have been condu Calibration Equipment used (M& Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 44198 | ertainties with confidence ucted in the closed laborate TE critical for calibration) ID # GB37480704 US37292783 SN: 2335 SN: 2335 SN: 6065 SN: 781 ID # ID # SN: GB42420191 | Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. 217-01451) 20-Apr-11 (No. 217-01451) | and are part of the certificate. //C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Apr-12 |
| The measurements and the uno All calibrations have been conde Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 44198 Power sensor HP 8482H | ertainties with confidence ucted in the closed laborate TE critical for calibration) ID # GB37480704 US37292783 SN: 2336 SN: 2336 SN: 6065 SN: 781 ID # SN: GB42420191 SN: 3318A09450 | probability are given on the following pages is ony facility: environment temperature (22 ± 3) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) | and are part of the certificate. VC and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Apr-12 Scheduled Check |
| The measurements and the unc All calibrations have been conde Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP 8482H Power sensor HP 8482A | ertainties with confidence ucted in the closed laborate ATE critical for calibration) ID # GB37480704 US37292783 SN: 2336 SN: 2336 SN: 6065 SN: 781 ID # ID # SN: GB42420191 SN: 3318A09450 SN: US37295597 | probability are given on the following pages is ory facility: environment temperature (22 ± 3) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) | and are part of the certificate. (*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Dec-12 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 |
| The measurements and the uno All calibrations have been conde Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe H3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP 8482H Power sensor HP 8482A Network Analyzer HP 8753E | ertainties with confidence ucted in the closed laborate ATE critical for calibration) ID # GB37480704 US37292783 SN: 2336 SN: 2336 SN: 6065 SN: 781 ID # ID # SN: GB42420191 SN: 3318A09450 SN: US37295597 US37390585 | cal Date (Certificate No.) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-236_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) | and are part of the certificate. (*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Apr-12 Scheduled Check In house check: Oct-12 In house check: Oct-12 |
| The measurements and the uno All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP 8482A Power sensor HP 8482A Network Analyzer HP 8753E | ertainties with confidence ucted in the closed laborate ATE critical for calibration) ID # GB37480704 US37292783 SN: 2336 SN: 2336 SN: 6065 SN: 781 ID # ID # SN: GB42420191 SN: 3318A09450 SN: US37295597 | probability are given on the following pages is ory facility: environment temperature (22 ± 3) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) | and are part of the certificate. (*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Dec-12 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 |
| The measurements and the uno All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 44198 Power sensor HP 8482H Power sensor HP 8482A Network Analyzer HP 8453E RF generator E4433B | ertainties with confidence ucted in the closed laborate ATE critical for calibration) ID # GB37480704 US37292783 SN: 2336 SN: 2336 SN: 2336 SN: 6065 SN: 781 ID # ID # SN: GB42420191 SN: 3318A09450 SN: US37295597 US37295597 US37295955 MY 41000675 * Name | cal Date (Certificate No.) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) 03-Nov-04 (in house check Oct-11) 5-Nov-04 (in house check Oct-11) Function | and are part of the certificate. (*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Dec-12 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 In house check: Oct-13 Signature |
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| The measurements and the uno All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 44198 Power sensor HP 8482H | ertainties with confidence ucted in the closed laborate ATE critical for calibration) ID # GB37480704 US37292783 SN: 2336 SN: 2336 SN: 2336 SN: 6065 SN: 781 ID # ID # SN: GB42420191 SN: 3318A09450 SN: US37295597 US37295597 US37295955 MY 41000675 * Name | cal Date (Certificate No.) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) 03-Nov-04 (in house check Oct-11) 5-Nov-04 (in house check Oct-11) Function | and are part of the certificate. VC and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Dec-12 Cot-12 Dec-12 Dec-12 Dec-12 Dec-12 Dec-12 Dec-12 Dec-12 Dec-12 In house check: Oct-12 In house check: Oct-13 |

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Report No. RXA1204-0112HAC01

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

[1] ANSI-C63.19-2007

American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Alds.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
 maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
 calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
 feed point.

Certificate No: CD835V3-1133_Feb12

Measurement Conditions

DASY system configuration, as far as not given on page 1.

| DASY Version | DASY5 | V52.8.0 |
|---------------------------------------|------------------------|---------|
| Extrapolation | Advanced Extrapolation | |
| Phantom | HAC Test Arch | |
| Distance Dipole Top - Probe Center | 10mm | |
| Scan resolution | dx, dy = 5 mm | |
| Frequency | 835MHz ± 1 MHz | |
| Input power drift | < 0.05 dB | |

Maximum Field values

| H-field 10 mm above dipole surface | condition | interpolated maximum | |
|------------------------------------|--------------------|----------------------------|--|
| Maximum measured | 100 mW input power | 0.456 A / m ± 8.2 % (k=2) | |
| E-field 10 mm above dipole surface | condition | Interpolated maximum | |
| Maximum measured above high end | 100 mW input power | 161.4 V / m | |
| Maximum measured above low end | 100 mW input power | 160.0 V / m | |
| Averaged maximum above arm | 100 mW input power | 160.7 V / m ± 12.8 % (k=2) | |

Appendix

Antenna Parameters

| Frequency | Return Loss | Impedance | |
|-----------|-------------|-------------------|--|
| 800 MHz | 15.7 dB | 42.6 Ω - 13.5 jΩ | |
| 835 MHz | 25.2 dB | 47.3 Ω + 4.7 jΩ | |
| 900 MHz | 17.9 dB | 52.9 Ω - 12.8 jΩ | |
| 950 MHz | 20.7 dB | 46.3 Ω + 8.2 jΩ · | |
| 960 MHz | 15.5 dB | 52.8 Ω + 17.3 jΩ | |

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

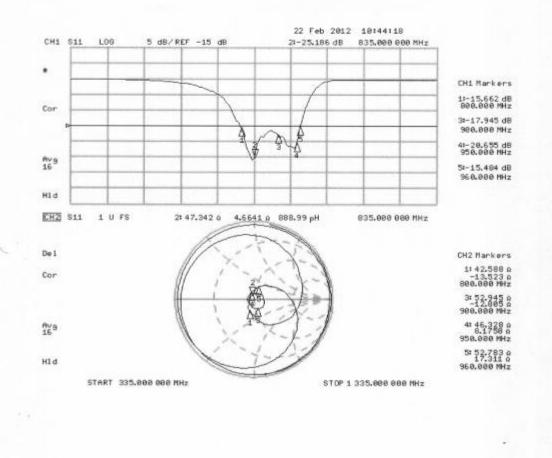
After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot



Certificate No: CD835V3-1133_Feb12

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Report No. RXA1204-0112HAC01

DASY5 H-field Result

Date: 21.02.2012

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1133

Communication System: CW; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

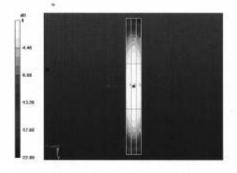
DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 29.12.2011 .
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.04.2011
- · Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.0(692); SEMCAD X 14.6.4(4989)

Dipole H-Field measurement @ 835MHz/H-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.49 V/m; Power Drift = 0.00 dB PMR not calibrated. PMF = 1.000 is applied. H-field emissions = 0.46 A/m Near-field category: M4 (AWF 0 dB)

PMF scaled H-field Grid 1 M4 Grid 2 M4 Grid 3 M4 0.38 A/m 0.40 A/m 0.39 A/m Grid 4 M4 Grid 5 M4 Grid 6 M4 0.43 A/m 0.46 A/m 0.44 A/m Grid 7 M4 Grid 8 M4 Grid 9 M4 0.37 A/m 0.40 A/m 0.39 A/m



0 dB = 0.46A/m = -6.74 dB A/m

Certificate No: CD835V3-1133_Feb12

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Report No. RXA1204-0112HAC01

DASY5 E-field Result

Date: 21.02.2012

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1133

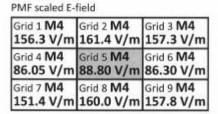
Communication System: CW; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

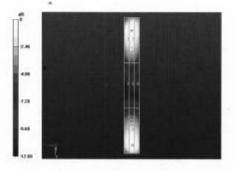
DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.04.2011
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.0(692); SEMCAD X 14.6.4(4989)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 104.5 V/m; Power Drift = 0.00 dB PMR not calibrated. PMF = 1.000 is applied. E-field emissions = 161.4 V/m

Near-field category: M4 (AWF 0 dB)





0 dB = 161.4V/m = 44.16 dB V/m

Certificate No: CD835V3-1133_Feb12

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ANNEX F: CD1880V3 Dipole Calibration Certificate

| Engineering AG ughausstrasse 43, 8004 Zuri | ch, Switzerland | | C Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service |
|---|---|--|---|
| credited by the Swiss Accreditu e Swiss Accreditation Servic ultilateral Agreement for the r | e is one of the signatori | es to the EA | on No.: SCS 108 |
| ient TA Shanghai (| Auden) | Certificate I | No: CD1880V3-1115_Feb12 |
| CALIBRATION | CERTIFICAT | E | |
| Object | CD1880V3 - SN | : 1115 | |
| Calibration procedure(s) | QA CAL-20.v6 Calibration proc | edure for dipoles in air | * |
| Calibration date: | February 21, 20 | 12 | |
| The measurements and the unc | ertainties with confidence | tional standards, which realize the physical i probability are given on the following pages ory facility: environment temperature (22 \pm 3 | and are part of the certificate. |
| The measurements and the unc NI calibrations have been condu Calibration Equipment used (M8 | ertainties with confidence ucted in the closed laboration TE critical for calibration) | probability are given on the following pages ory facility: environment temperature (22 ± 3 | and are part of the certificate.)°C and humidity < 70%. |
| The measurements and the unc NI calibrations have been cond Calibration Equipment used (M& Primary Standards | ertainties with confidence ucted in the closed laborati &TE critical for calibration) ID # | probability are given on the following pages ory facility: environment temperature (22 ± 3 Cal Date (Certificate No.) | and are part of the certificate.)°C and humidity < 70%. Scheduled Calibration |
| he measurements and the unc all calibrations have been conde alibration Equipment used (M8 himary Standards ower meter EPM-442A | artainties with confidence ucted in the closed laboration &TE critical for calibration) ID # GB37480704 | probability are given on the following pages ory facility: environment temperature (22 ± 3 Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) | and are part of the certificate.)°C and humidity < 70%. Scheduled Calibration Oct-12 |
| The measurements and the uno NI calibrations have been conde Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A | artainties with confidence ucted in the closed laboration RTE critical for calibration) ID # GB37480704 US37292783 | probability are given on the following pages ory facility: environment temperature (22 ± 3 Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) | and are part of the certificate.)°C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Oct-12 |
| The measurements and the uno NI calibrations have been conde Calibration Equipment used (M8 Primary Standards Power sensor HP 8481A Probe ER3DV6 | artainties with confidence ucted in the closed laboration RTE critical for calibration) ID # GB37480704 US37292783 SN: 2336 | probability are given on the following pages ory facility: environment temperature (22 ± 3 Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) | and are part of the certificate.)°C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Oct-12 Dec-12 |
| The measurements and the uno All calibrations have been conde Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 | artainties with confidence ucted in the closed laboration RTE critical for calibration) ID # GB37480704 US37292783 | probability are given on the following pages ory facility: environment temperature (22 ± 3 Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) | and are part of the certificate.)°C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Oct-12 |
| The measurements and the uno NI calibrations have been conde Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Probe ER3DV6 Probe ER3DV6 Probe H3DV6 DAE4 | artainties with confidence ucted in the closed laboration RTE critical for calibration) ID # GB37480704 US37292783 SN: 2336 SN: 6065 | Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) | and are part of the certificate.)*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 |
| The measurements and the unc All calibrations have been condu Calibration Equipment used (M& Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B | ertainties with confidence ucted in the closed laboration) ID # GB37480704 US37292783 SN: 2336 SN: 2336 SN: 6065 SN: 781 ID # ID # | cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) | and are part of the certificate.)*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Apr-12 |
| The measurements and the unc All calibrations have been condu Calibration Equipment used (Mé Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP 8482H | actainties with confidence ucted in the closed laboration ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID # ID # SN: 318A09450 | cal Date (Certificate No.) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) | and are part of the certificate.)°C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Apr-12 Scheduled Check In house check: Oct-12 In house check: Oct-12 |
| The measurements and the unc All calibrations have been conde Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe EP3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP 8482H Power sensor HP 8482A | actainties with confidence ucted in the closed laboration ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID # SN: 6B42420191 SN: 3318A09450 SN: US37295597 | cal Date (Certificate No.) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-236_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) | and are part of the certificate.)*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Apr-12 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 |
| The measurements and the uno All calibrations have been conde Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe H3DV6 Probe H3DV6 Probe H3DV6 Power sensor HP 8482A Power sensor HP 8482A Network Analyzer HP 8753E | actainties with confidence ucted in the closed laboration BTE critical for calibration) ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID # SN: 3318A09450 SN: US37295597 US37390585 | cal Date (Certificate No.) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-236_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) | and are part of the certificate.)*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Apr-12 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 |
| The measurements and the uno All calibrations have been conde Calibration Equipment used (M8 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe H3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP 8482H Power sensor HP 8482A Network Analyzer HP 8753E | actainties with confidence ucted in the closed laboration ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781 ID # SN: 6B42420191 SN: 3318A09450 SN: US37295597 | cal Date (Certificate No.) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-236_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) | and are part of the certificate.)*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Apr-12 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 |
| The measurements and the uno All calibrations have been conde Calibration Equipment used (Mé Primary Standards Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power sensor HP 8482H Power sensor HP 8482H Power sensor HP 8482A Network Analyzer HP 8753E RF generator E44338 | Artainties with confidence ucted in the closed laboration ID # GB37480704 US37292783 SN: 2336 SN: 2336 SN: 6065 SN: 781 ID # ID # | probability are given on the following pages ory facility: environment temperature (22 ± 3) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) 03-Nov-04 (in house check Oct-11) 03-Nov-04 (in house check Oct-11) | and are part of the certificate.)*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Apr-12 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 In house check: Oct-13 Signature |
| The measurements and the uno All calibrations have been conde Calibration Equipment used (Mé Primary Standards Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power sensor HP 8482H Power sensor HP 8482H Power sensor HP 8482A Network Analyzer HP 8753E RF generator E44338 | Artainties with confidence ucted in the closed laboration ID # GB37480704 US37292783 SN: 2336 SN: 2336 SN: 6065 SN: 781 ID # ID # | probability are given on the following pages ory facility: environment temperature (22 ± 3) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) 03-Nov-04 (in house check Oct-11) 03-Nov-04 (in house check Oct-11) | and are part of the certificate.)*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Apr-12 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 In house check: Oct-13 Signature |
| The measurements and the unc | Artainties with confidence ucted in the closed laboration ID # GB37480704 US37292783 SN: 2336 SN: 2336 SN: 6065 SN: 781 ID # ID # | probability are given on the following pages ory facility: environment temperature (22 ± 3) Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 20-Apr-11 (No. DAE4-781_Apr11) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) 18-Oct-01 (in house check Oct-11) 03-Nov-04 (in house check Oct-11) 03-Nov-04 (in house check Oct-11) | and are part of the certificate.)*C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Apr-12 Scheduled Check In house check: Oct-12 In house check: Oct-13 |

Certificate No: CD1880V3-1115_Feb12 Pag

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Schwelzerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

- [1] ANSI-C63.19-2007
 - American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
 maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
 calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
 feed point.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

| DASY Version | DASY5 V52.8.0 | | | |
|---------------------------------------|------------------------|--|--|--|
| Extrapolation | Advanced Extrapolation | | | |
| Phantom | HAC Test Arch | | | |
| Distance Dipole Top - Probe Center | 10mm | | | |
| Scan resolution | dx, dy = 5 mm | | | |
| Frequency | 1880MHz ± 1 MHz | | | |
| Input power drift | < 0.05 dB | | | |

Maximum Field values

| condition | interpolated maximum |
|--------------------|---|
| 100 mW input power | 0.473 A / m ± 8.2 % (k=2) |
| condition | Interpolated maximum |
| 100 mW input power | 143.4 V / m |
| 100 mW input power | 139.6 V / m |
| 100 mW input power | 141.5 V / m ± 12.8 % (k=2) |
| | 100 mW input power condition 100 mW input power 100 mW input power |

Appendix

Antenna Parameters

| Frequency | Return Loss | Impedance | |
|-----------|-------------|-------------------|--|
| 1730 MHz | 30.5 dB | 52.6 Ω + 1.5 jΩ | |
| 1880 MHz | 21.7 dB | 46.1 Ω + 6.9 jΩ | |
| 1900 MHz | 22.0 dB | 47.6 Ω + 7.4 jΩ | |
| 1950 MHz | 29.8 dB | 49.9 Ω + 3.2 jΩ · | |
| 2000 MHz | 18.9 dB | 41.3 Ω + 5.6 jΩ | |

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

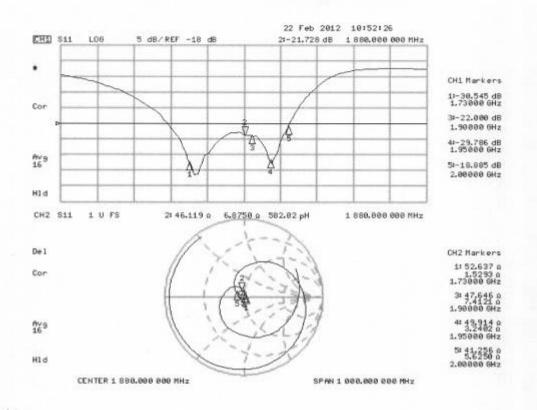
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot



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Report No. RXA1204-0112HAC01

DASY5 H-field Result

Date: 21.02.2012

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1115

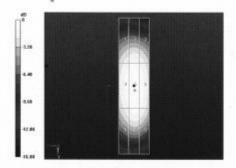
Communication System: CW; Frequency: 1880 MHz Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.04.2011
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.0(692); SEMCAD X 14.6.4(4989)

Dipole H-Field measurement @ 1880MHz/H-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.50 V/m; Power Drift = -0.01 dB PMR not calibrated. PMF = 1.000 is applied. H-field emissions = 0.47 A/m Near-field category: M2 (AWF 0 dB) PMF scaled H-field

| Grid 1 M2 0.40 A/m | | |
|-----------------------|-----------------------|--|
| Grid 4 M2 0.45 A/m | | |
| | Grid 8 M2 0.44 A/m | |



0 dB = 0.47A/m = -6.56 dB A/m

Certificate No: CD1880V3-1115_Feb12

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Report No. RXA1204-0112HAC01

DASY5 E-field Result

Date: 21.02.2012

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1115

Communication System: CW; Frequency: 1880 MHz Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

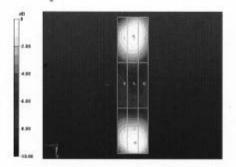
DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.04.2011
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.0(692); SEMCAD X 14.6.4(4989)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 161.1 V/m; Power Drift = -0.01 dB PMR not calibrated. PMF = 1.000 is applied. E-field emissions = 143.4 V/m Near-field category: M2 (AWF 0 dB)

PMF scaled E-field

| Grid 1 M2 | Grid 2 M2 | Grid 3 M2 | |
|-----------|------------------------|-----------|--|
| 134.3 V/m | 139.6 V/m | 136.5 V/m | |
| | Grid 5 M3 93.17 V/m | | |
| Grid 7 M2 | Grid 8 M2 | Grid 9 M2 | |
| 134.3 V/m | 143.4 V/m | 141.8 V/m | |



0 dB = 143.4V/m = 43.13 dB V/m

Certificate No: CD1880V3-1115_Feb12

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.

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ANNEX G: DAE4 Calibration Certificate

| ognadoonabae 40, 0004 2010 | h, Switzerland | Hac MRA | C Service suisse d'étalonnage Servizio svizzero di taratura S Swiss Calibration Service |
|--|---|---|--|
| Accredited by the Swiss Accredita The Swiss Accreditation Servic Multilateral Agreement for the r | e is one of the signatories | to the EA | Itation No.: SCS 108 |
| Client TA Shanghai (| Auden) | Certific | ate No: DAE4-1317_Jan12 |
| CALIBRATION O | CERTIFICATE | | per separate services |
| Object | DAE4 - SD 000 D | 04 BJ - SN: 1317 | |
| Calibration procedure(s) | QA CAL-06.v24 Calibration procee | dure for the data acquisition | electronics (DAE) |
| Calibration date: | January 23, 2012 | | |
| The measurements and the unce | rtainties with confidence pro | anal standards, which realize the physi obability are given on the following page | ges and are part of the certificate. |
| The measurements and the unce All calibrations have been condu | rtainties with confidence pro | | ges and are part of the certificate. |
| The measurements and the unce All calibrations have been condu Calibration Equipment used (M& Primary Standards | rtainties with confidence pro- cted in the closed laboratory TE critical for calibration) | obability are given on the following pay (facility: environment temperature (22) Cal Date (Certificate No.) | ges and are part of the certificate. ± 3)°C and humidity < 70%. Scheduled Calibration |
| The measurements and the unce All calibrations have been condui Calibration Equipment used (M& Primary Standards | rtainties with confidence protected in the closed laboratory | obability are given on the following pag | ges and are part of the certificate. ± 3)°C and humidity < 70%. |
| The measurements and the unce All calibrations have been condui Calibration Equipment used (M& Primary Standards Keithley Multimeter Type 2001 Secondary Standards | rtainties with confidence pro- cted in the closed laboratory TE critical for calibration) ID # SN: 0810278 | obability are given on the following page (facility: environment temperature (22) Cal Date (Certificate No.) 28-Sep-11 (No:11450) Check Date (in house) | ges and are part of the certificate. ± 3)°C and humidity < 70%. Scheduled Calibration Sep-12 Scheduled Check |
| The measurements and the unce All calibrations have been condui Calibration Equipment used (M& Primary Standards | rtainties with confidence pro- cted in the closed laboratory TE critical for calibration) ID # SN: 0810278 | obability are given on the following page (facility: environment temperature (22 Cal Date (Certificate No.) 28-Sep-11 (No:11450) | ges and are part of the certificate. ± 3)°C and humidity < 70%, Scheduled Calibration Sep-12 |
| The measurements and the unce All calibrations have been condui Calibration Equipment used (M& Primary Standards Keithley Multimeter Type 2001 Secondary Standards | rtainties with confidence pro- cted in the closed laboratory TE critical for calibration) ID # SN: 0810278 | obability are given on the following page (facility: environment temperature (22) Cal Date (Certificate No.) 28-Sep-11 (No:11450) Check Date (in house) | ges and are part of the certificate. ± 3)°C and humidity < 70%. Scheduled Calibration Sep-12 Scheduled Check |
| The measurements and the unce All calibrations have been condui Calibration Equipment used (M& <u>Primary Standards</u> Keithley Multimeter Type 2001 Secondary Standards Calibrator Box V2.1 | rtainties with confidence pro- cted in the closed laboratory TE critical for calibration) ID # SN: 0810278 ID # SE UWS 053 AA 1001 | obability are given on the following pag (facility: environment temperature (22 Cal Date (Certificate No.) 28-Sep-11 (No:11450) Check Date (in house) 05-Jan-12 (in house check) | ges and are part of the certificate. ± 3)°C and humidity < 70%, Scheduled Calibration Sep-12 Scheduled Check In house check: Jan-13 |
| The measurements and the unce All calibrations have been condui Calibration Equipment used (M& <u>Primary Standards</u> Keithley Multimeter Type 2001 <u>Secondary Standards</u> Calibrator Box V2.1 Calibrated by: | ID # SE UWS 053 AA 1001 | Cal Date (Certificate No.) 28-Sep-11 (No:11450) Check Date (in house) 05-Jan-12 (in house check) Function Technician | ges and are part of the certificate. ± 3)°C and humidity < 70%, Scheduled Calibration Sep-12 Scheduled Check In house check: Jan-13 |
| The measurements and the unce All calibrations have been condui Calibration Equipment used (M& <u>Primary Standards</u> Keithley Multimeter Type 2001 <u>Secondary Standards</u> Calibrator Box V2.1 Calibrated by: Approved by: | Artainties with confidence pro- cted in the closed laboratory TE critical for calibration) ID # SN: 0810278 ID # SE UWS 053 AA 1001 SE UWS 053 AA 1001 Name Dominique Steffen Fin Bomholt | Cal Date (Certificate No.) 28-Sep-11 (No:11450) Check Date (in house) 05-Jan-12 (in house check) Function Technician | signature |

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



S

Schweizerischer Kalibrierdienst s Service suisse d'étalonnage С

Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary

DAE Connector angle

data acquisition electronics information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by ٠ comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter ٠ corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

| A/D - | Conver | ter F | leso | lutic |
|-------|--------|-------|------|-------|
| | | | | |

| High Range: | 1LSB = | 6.1µV . | full range = | -100+300 mV |
|-------------|--------|---------|--------------|-------------|
| Low Range: | 1LSB = | 61nV . | full range = | -1+3mV |

| Calibration Factors | x | Y | z |
|---------------------|----------------------|----------------------|----------------------|
| High Range | 404.064 ± 0.1% (k=2) | 404.056 ± 0.1% (k=2) | 403.955 ± 0.1% (k=2) |
| Low Range | 3.98762 ± 0.7% (k=2) | 3.98737 ± 0.7% (k=2) | 3.98343 ± 0.7% (k=2) |

Connector Angle

| Connector Angle to be used in DASY system | 117.0°±1° |
|---|-----------|
|---|-----------|

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Appendix

1. DC Voltage Linearity

| High Range | Reading (µV) | Difference (µV) | Error (%) |
|-------------------|--------------|-----------------|-----------|
| Channel X + Input | 199992.18 | -1.75 | -0.00 |
| Channel X + Input | 20001.35 | 0.46 | 0.00 |
| Channel X - Input | -19997.31 | 1.96 | -0.01 |
| Channel Y + Input | 199993.18 | -1.24 | -0.00 |
| Channel Y + Input | 20001.40 | 0.60 | 0.00 |
| Channel Y - Input | -20000.04 | -0.70 | 0.00 |
| Channel Z + Input | 199991.58 | -2.43 | -0.00 |
| Channel Z + Input | 19999.62 | -1.14 | -0.01 |
| Channel Z - Input | -20001.31 | -1.83 | 0.01 |

| Reading (µV) | Difference (µV) | Error (%) |
|--------------|---|--|
| 2000.74 | -0.89 | -0.04 |
| 202.18 | -0.01 | -0.01 |
| -197.58 | 0.36 | -0.18 |
| 2000.34 | -1.20 | -0.06 |
| 199.67 | -2.39 | -1.18 |
| -197.64 | 0.32 | -0.16 |
| 2000.69 | -0.78 | -0.04 |
| 200.84 | -1.16 | -0.57 |
| -198.45 | -0.47 | 0.24 |
| | 2000.74 202.18 -197.58 2000.34 199.67 -197.64 2000.69 200.84 | 2000.74 -0.89 202.18 -0.01 -197.58 0.36 2000.34 -1.20 199.67 -2.39 -197.64 0.32 2000.69 -0.78 200.84 -1.16 |

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | Common mode Input Voltage (mV) | High Range Average Reading (μV) | Low Range Average Reading (µV) |
|-----------|-----------------------------------|------------------------------------|-----------------------------------|
| Channel X | 200 | -23.40 | -24.98 |
| | - 200 + | 28.01 | 26.12 |
| Channel Y | 200 | -2.57 | -2.75 |
| | - 200 | 1.67 | 1.31 |
| Channel Z | 200 | -11.92 | -11.43 |
| | - 200 | 9.80 | 9.45 |

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | Input Voltage (mV) | Channel X (µV) | Channel Y (µV) | Channel Z (µV) |
|-----------|--------------------|----------------|----------------|----------------|
| Channel X | 200 | | -2.15 | -4.41 |
| Channel Y | 200 | 7.18 | - | -2.47 |
| Channel Z | 200 | 7.44 | 5.46 | |

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | High Range (LSB) | Low Range (LSB) |
|-----------|------------------|-----------------|
| Channel X | 16081 | 17027 |
| Channel Y | 16103 | 16170 |
| Channel Z | 16221 | 16651 |

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

| | Average (µV) | min. Offset (µV) | max. Offset (µV) | Std. Deviation (µV) |
|-----------|--------------|------------------|------------------|------------------------|
| Channel X | -0.45 | -1.32 | 0.40 | 0.32 |
| Channel Y | -2.63 | -3.99 | -1.68 | 0.42 |
| Channel Z | -0.67 | -3.07 | 1.36 | 0.50 |

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

| | Zeroing (kOhm) | Measuring (MOhm) |
|-----------|----------------|------------------|
| Channel X | 200 | 200 |
| Channel Y | 200 | 200 |
| Channel Z | 200 | 200 |

8. Low Battery Alarm Voltage (Typical values for information)

| Typical values | Alarm Level (VDC) | |
|----------------|-------------------|--|
| Supply (+ Vcc) | +7,9 | |
| Supply (- Vcc) | -7.6 | |

9. Power Consumption (Typical values for information)

| Typical values | Switched off (mA) | Stand by (mA) | Transmitting (mA) |
|----------------|-------------------|---------------|-------------------|
| Supply (+ Vcc) | +0.01 | +6 | +14 |
| Supply (- Vcc) | -0.01 | -8 | -9 |

ANNEX H: The EUT Appearances and Test Configuration



a: EUT



b: Battery 1

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c: Battery 2

Picture 1: Constituents of EUT

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Picture 2: Test Setup